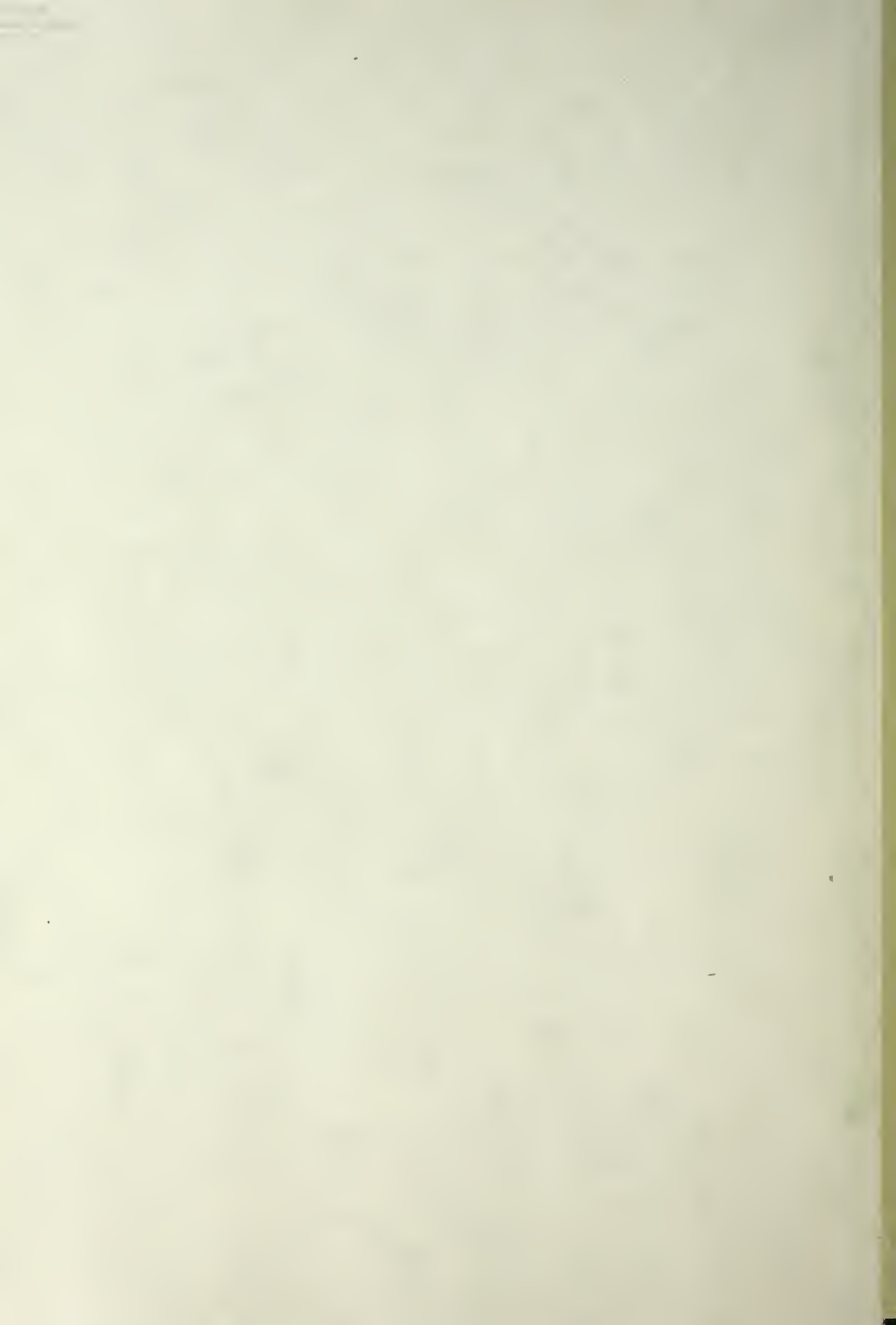


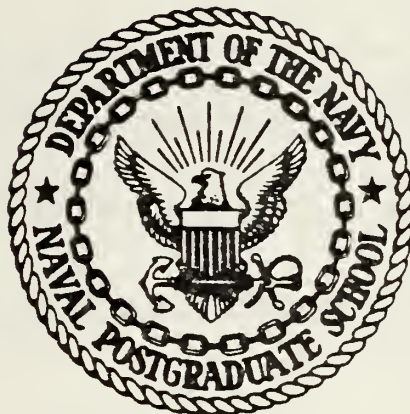
COMPUTER PROGRAM FOR THE KINETICS AND
POPULATIONS IN A XENON FLUORIDE LASER

Lonnie William Cole



NAVAL POSTGRADUATE SCHOOL

Monterey, California



THESIS

COMPUTER PROGRAM FOR THE KINETICS AND
POPULATIONS IN A XENON FLUORIDE LASER

by

Lonnie William Cole

December 1979

Thesis Advisor:

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Computer Program for the Kinetics and
Populations in a Xenon Fluoride Laser

by

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Lieutenant, United States Navy
B. S., United States Naval Academy, 1973

Submitted in partial fulfillment of the
requirements for the degree of

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ABSTRACT

To highlight in a qualitative manner the kinetics of an excimer laser, a simple computer model for calculating the species populations in a KrF laser cavity is developed; subsequently a computer program originally developed at the Naval Research Laboratory (NRL) is modified to calculate the population of the different electronic configurations of excited neon present in a XeF laser. When modified, the NRL program accounts for 185 reactions and requires 9.5 minutes of CPU time using the IBM 360/67. The populations obtained are applied to the calculation of the index of refraction in the laser cavity. The phase shift is determined per unit length for the two laser wavelengths; one laser wavelength is non-resonance with neon and the other is at resonance. Neon is the dominant specie relative to concentration and within the population distribution the neon ground state dominates by a factor of a million. The calculations show that the ground state neon determines the index of refraction; an exception occurs if the laser wavelength is near resonance to any of the transitions in the $3s \rightarrow 4p$ array. As long as the laser is operated away from the $3s \rightarrow 4p$ resonant wavelengths, the phase shift will be negligibly small resulting in satisfactory beam quality; the preceding statement is valid only for the influence of neon.

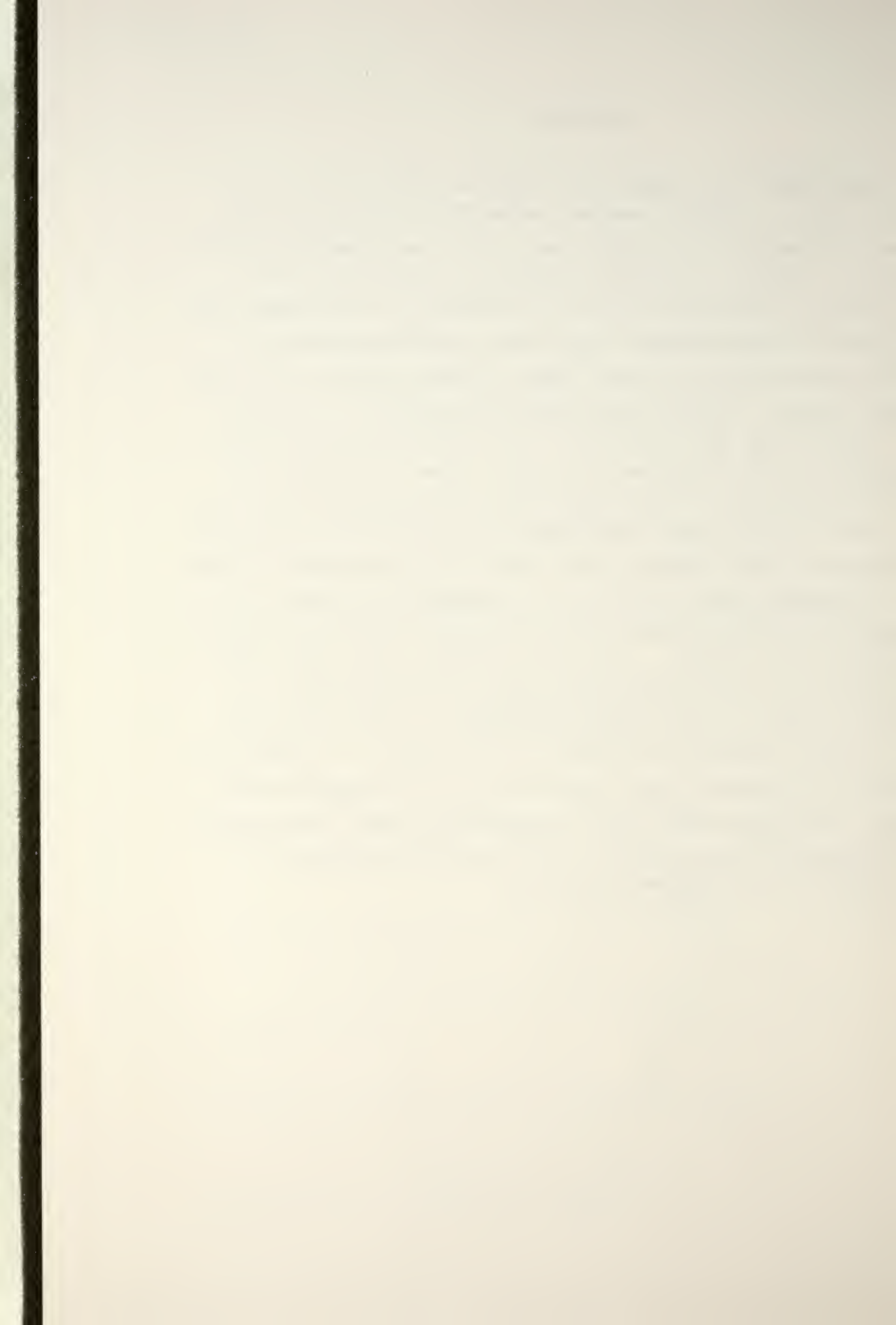


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This thesis is dedicated to my wife whose support and devotion throughout my graduate studies has raised me to this new plateau.

I. INTRODUCTION

The rare-gas monohalides, such as XeF, are simple diatomic molecules whose properties and emission spectra were essentially unknown as recently as five years ago. Now they are the active media for gas lasers that could provide overall electrical efficiency as high as 10 per cent in various wavelengths, as depicted in Table I.

Table I. Rare-gas Halide Laser Emission Wavelengths

	<u>Peak wavelengths of most intense band (nm)</u>			
	Ne	Ar	Kr	Xe
F	107 ^a	193	248	351, 353
Cl	b	170	222	308
Br	b	166 ^{a, b}	206 ^a	282
I	b	b	185 ^{a, b}	252 ^a

^aHas not demonstrated laser oscillation.

^bPredissociates, hence emission is weak or unobservable.

The overall efficiency as explained by J. J. Ewing and C. A. Brau [1] is

...a product of a quantum efficiency, an upper laser level production efficiency, an extraction efficiency, an efficiency for producing the initial excited states by the pump, and an energy coupling efficiency which describes the efficiency with which energy gets from a wall socket into the gas medium. The extraction efficiency is comprised of both spectroscopic and kinetic extraction efficiencies

depending on the ratio of net gain to loss and the ratio of rates of stimulated emission of upper laser levels to the quenching and spontaneous loss of upper levels. Certain rare gas halide lasers have potential for high power and high efficiency because they have high efficiency in each of the above mentioned elements. Depending on the application requirements, one may accept a lower efficiency of one of these elements if the compromise allows for some simplification of the laser. Typically this trade off usually involves coupling and excited state production efficiencies.

Rare-gas monohalides belong to a larger class of molecules broadly known as excimers. An excimer is an atomic or molecular aggregate, composed of two atoms or molecules, that is bound in its excited state but is unstable or slightly bound in the ground state.

The term "excimer" is standard chemical nomenclature for dimers which are bound in the excited state and free in the lower state. In standard nomenclature dimer means two of the same thing. Thus, Xe_2^* , Ar_2^* , etc. are excimers. Species that are heteronuclear such as LiXe^* or KrF^* also can have bound excited states and dissociative lower states. The accepted chemical nomenclature for such species is "exciplex" short for excited complex. Unfortunately, the laser community has not uniformly utilized good scientific English and typically calls all species with dissociative lower states, and even some like XeF with slightly bound lower states, "excimers".

The excited state of the excimer species can radiate in a broad band that is red shifted from the wavelength of the parent atomic excitation. The size of the bandshift

depends on the depth of the excited state well (typically 1-5eV) and on the repulsion of the lower state at the energy minimum of the excimer. In Figure 1 are schematic potential energy curves for an excimer.

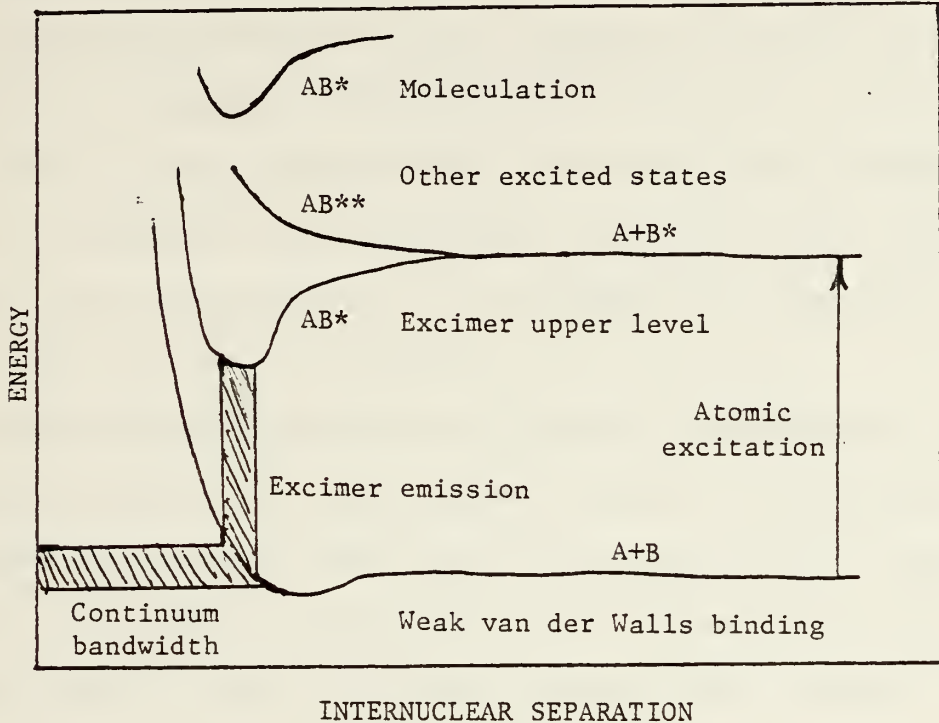


Figure 1. Potential Energy of Excimers (Reproduced from Ewing [2]).

Excimer emission spectra are useful for lasers because the lower level rapidly dissociates. Since the dissociation time, about 10^{-12} second, is much less than upper level radiative lifetimes, 10^{-9} to 10^{-6} second, population inversions can be readily produced and maintained.

The excimer laser or exciplex laser offers features which are essential for military applications [2-4]. These features are as follows: first, the potential for high efficiency; second, scalability to large volume and high power; and, third, transmission through the atmosphere

using either directly-generated photons or frequency-converted photons [5]. As a result of the attractive characteristics, considerable effort has been and is being directed toward identification of key technical issues and establishment of feasible solutions to the problems identified [6-11]. In addition to research directed toward the laser device itself, work is also being funded on related and relevant aspects, including e-beam technology, UV optics, and time dependent laser aerodynamics. For example, see Bennett, et al. [12] for work on UV optics.

Systems studies have been conducted by Rocketdyne. Among the various aspects of large excimer lasers considered in the Rocketdyne reports was beam quality as influenced by non-uniformity of index of refraction. The adverse impact of poor beam quality upon the overall system was stressed.

For military applications the optimum pulse duration should be a few microseconds [13-15]. The pulse duration for some military applications is in contrast to the desired pulse duration of a few nanoseconds for inertial confinement to achieve thermonuclear fusion [1]. Even if a pulse duration of 10 microseconds is used, the motion of the waves, e.g., cathode shock wave and anode wave, in the gas will be very small, i.e., of the order of

$$\lambda = a \tau = (300 \text{ m/sec}) (10^{-5} \text{ sec}) = 3 \text{ mm} \quad (1)$$

where a is the acoustic wave speed and τ is the pulse duration. However, this fact does not suggest that a pulsed

excimer laser will be free of inhomogeneity problems; extensive experience with pulsed electrical lasers operating in the IR indicates that beam quality may be a problem. To achieve high average power, a large pulse repetition frequency, PRF, must be used which requires a flowing laser. The higher the PRF, the faster the gas flow is.

Gas flow in a high power, high PRF, excimer laser will probably be subsonic. In subsonic flow [16-18], disturbances can propagate upstream. Even if the upstream base flow is perfect, the gas moving out of the cavity after a pulse can cause $\Delta n/n$ within the cavity; n is index of refraction, and Δn is spatial variation of index of refraction. A large flush factor eases the problem of a nonuniform base flow; however, high efficiency demands a low flush factor.

Nonuniformity of the lasing medium may have adverse effects distinct from the deterioration of beam quality. The work of Nerheim and Chen [19] at JPL indicates different levels of performance depending on homogeneity of the gas. Pulses into a homogeneous medium resulted in one level of power output; pulses into an inhomogeneous medium yielded another level (lower naturally) of performance. Details of the physics involved in this observation were not unraveled. The work by Nerheim and Chen was with an atomic copper laser. Consequently the results are not directly transferable to rare gas-halide lasers.

Despite the many unsolved problems regarding excimer lasers, its use as a potential weapon constitutes a

revolution greater than the leap from naval guns to guided missiles. Some of the conceivable missions for the excimer laser are ballistic missile defense (both ground-based silo defense and space-based destruction of ICBMs in the boost phase), space-based antisatellite defense, and antiship missile defense (ASMD) [20]. The latter has the most promise of relatively near-term development. Also, the radiation from certain excimer lasers has good propagation in sea water.

Briefly, the laser offers the advantage of depositing an extremely high energy on a small area of a target. This destructive energy is delivered at the speed of light (300 million meters per second which is ideal for a defensive system against missiles); whereas, a conventional missile travels to its target at a speed of a few times the speed of sound (roughly 1500 meters per second).

As alluded to earlier, beam quality has an important impact upon the overall laser system. Improvements in beam quality can be used to decrease overall laser size, shorten time for melting a metal, or decrease laser run time to perform a certain task. A well know fact is that beam quality depends on favorable illumination of the exit aperture; favorable illumination implies near constant phase and, to a lesser degree, near constant amplitude. Variation of the index of refraction within the cavity causes spatial variation in phase at the laser exit. This

nonuniform phase causes the peak axis intensity, I_{ff} , to decrease according to

$$\frac{I_{ff}}{I_o} = \exp [-(2\pi\phi_{rms}/\lambda)^2] \quad (2)$$

where λ is wavelength. The rms phase, ϕ_{rms} , is obtained by squaring and averaging the phase shifts across the aperture. Equation (2) is the Strehle Ratio [21]. The spatial phase relation is

$$\phi = \int n ds \quad (3)$$

where ds is an incremental distance along a ray in the laser cavity. The initial efforts to limit phase distortion considered the index of refraction in terms of the Gladstone-Dale formulation

$$n = 1 + G\rho \quad (4)$$

where ρ is gas density, and G is the Gladstone-Dale constant; hence there is concern for flow and acoustic effects. Hogge and Crow [22] state that flow uniformity and reduced acoustic effects have achieved $\Delta\rho/\rho = 5 \times 10^{-5}$, which is the required flow uniformity.

It has been suggested, however, that the requirement for flow uniformity should be stated in terms of $\Delta n/n$ due to nonuniform pumping in the cavity [23]. In a typical flow mixture, the constituents of the medium (Ne:Xe:NF₃) are

present in a fixed ratio (750:3:1) [24]. Even in a gas with fixed chemical composition, pressure and translational temperature, and hence, fixed $\Delta\rho/\rho$, $\Delta n/n$ can vary according to the ionic and electronic excitation of the medium caused by pumping.

Consider the Ladenburg formulation of the Kramers-Kronig dispersion relation [25]

$$n-1 = \frac{e^2 N}{2\pi m_e c^2} \sum_{\ell} \frac{N_{\ell}}{N} \sum_j \sum_k \frac{\lambda_{kj}^2}{\lambda^2 - \lambda_{kj}^2} f_{kj} \left[1 - \frac{N_k g_j}{N_j g_k} \right] .$$

(5)

- e electron charge
- c speed of light
- m_e mass of electron
- N total number
- λ_{kj} wavelength for transition between k and j
- λ wavelength of interest at which n is derived
- f_{kj} is oscillator strength for transition from k to j
- g_j is degeneracy of j^{th} energy level
- N_j population in j^{th} energy level

There are ℓ distinct species indicating specific electronic or ionic excitation present in the cavity. Index j sums over lower levels and k over upper levels of possible configurations. Identify the mole fraction as

$$X_{\ell} = \frac{N_{\ell}}{N} \quad (6)$$

the fraction of the total molecular population represented by species ℓ . Finally, define a quantity

$$T_{\ell} = \frac{e^2}{2\pi m_e c^2} \sum_j \sum_k \frac{\lambda_{kj}^2 \lambda^2}{\lambda^2 - \lambda_{kj}^2} f_{kj} \left[1 - \frac{N_k}{N_j} \frac{g_j}{g_k} \right] \quad (7)$$

In terms of the quantities defined above

$$n-1 = N \sum_{\ell} X_{\ell} T_{\ell} \quad (8)$$

or the index of refraction in the cavity is the sum of the contributions of all the species present in the cavity.

Since $N_{\ell} = NX_{\ell}$,

$$n-1 = N_1 T_1 + N_2 T_2 + \dots \quad (9)$$

The partial density is given by $\rho_{\ell} = N_{\ell} m_{\ell}$ where m_{ℓ} is the molecular weight of ℓ^{th} species. In terms of partial density, equation (9) becomes

$$n-1 = \rho_1 T_1 / m_1 + \rho_2 T_2 / m_2 + \dots \quad (10)$$

Introduce the mass fraction for the gas mixture $Y_{\ell} = \rho_{\ell} / \rho$, where ρ is the density of the gas mixture. The result is

$$n-1 = \rho [Y_1 T_1 / m_1 + Y_2 T_2 / m_2 + \dots] \quad (11)$$

Equation (11) shows that $n-1$ is proportional to ρ ; however, equation (11) further demonstrates that $n-1$ depends on mass fraction and index of refraction of each species. Even with uniform flow, the spatial phase relation across the cavity will not be uniform. Accurate modeling of the phase effects requires knowledge of the species populations and the contribution to the index of refraction of the species in the cavity. This thesis will explore a model for determining the species populations in a laser cavity and apply a model originally developed at the Naval Research Laboratory (NRL) to calculate the populations of the different configurations of excited Neon present in a XeF laser.

First, in section II, a review of electronic transition gas laser kinetics is discussed. Second, in section III, a simple model for an excimer (KrF) laser is developed. Third, in section IV, the computer program developed and written at NRL by Johnson, Palumbo, and Hunter [26] is discussed. Fourth, in section V, a formulation of input reactions to the NRL program to calculate the populations of excited neon configurations is developed. Fifth, in section VI, calculation of the index of refraction is performed. Sixth, in section VII, the calculation of phase shift is performed. Lastly, in section VIII, the results are discussed.

II. KINETICS

Electronic transition gas lasers (i.e. exciplex or excimer) generally involve complex, branching chains of energy flow from initial pump excitation of background gas to eventual extraction of laser radiation. Figure 2 illustrates major energy flow pathways in e-beam pumped Ne/Xe/NF₃ mixtures. These energy chains include processes such as: energy deposition by electron ionization and excitation; energy transfer by various collisional mechanisms, including neutralization, displacement and "harpooning", leading to formation of the upper laser level; and collisional mechanisms which intercept excitation energy before it can reach the upper laser level, or which quench that level before stimulated emission occurs. Also, one must consider extraction of stimulated emission including absorptions by various processes in the gas and resonant reabsorption by the lower laser level (if there is one), laser cavity oscillation, and coupling through output mirrors. A time-dependent model of the kinetics of such a system must define and update species densities for a large number--typically between 20 and 60--gas components, including ground states, several excited states and ions of atoms and molecules, plus electrons and photons.

The time evolution of these components is followed by the solution of a set of coupled first order ordinary

differential equations; one equation is required for each gas component. To the set of equations defining species densities are added further equations describing the evolution of the photon field, the gas temperature, and (in some models) coupled electrical circuit parameters. The species equations can be generally described as equating the rate of change of species density to a sum of contributing formation terms less a sum of depletion terms as

$$\frac{dN_i}{dt} = \sum_j F_{ji} - \sum_k D_{ik} \quad (12)$$

Here N_i is a particular species density, the F_{ji} are the formation terms, and the D_{ik} the depletion terms. For example, consider a simple chemical reaction of the form $A + B \rightarrow C + D$ whose forward rate constant is k ; if the species densities are expressed in cm^{-3} , the units of k are cm^3/sec . For this reaction, the rate equations defining species C and D would contain the formation term

$$F = k[A][B] ; \quad (13)$$

at the same time, the equations defining species A and B would contain the depletion term

$$D = k[A][B] . \quad (14)$$

Recall that square brackets for a chemical symbols means number density of the chemical with dimensions $1/\text{cm}^3$.

Consider equation (12) again. Species i is formed in j different reactions. Likewise, species i is depleted in k different reactions.

III. A SIMPLE KINETICS MODEL FOR KrF

In a thorough model of an excimer laser a large number of kinetic reactions are necessary; see, for instance, the 185 reactions listed in the output of the NRL program for XeF (Appendix A). The reactions are used to obtain the set of coupled first order differential equations. The solution to this set of equations is very involved and tedious because of the difficulty in handling the tangle of reactions. Therefore, only a few of the kinetic reactions in a KrF laser are considered. The object of the simple computer model was to obtain a qualitative insight to excimer laser kinetics.

The model uses a He/Kr/F₂ mixture (98.1/1.77/0.13) with He as diluent. Figure 3 illustrates a simplified e-beam pumped KrF laser geometry.

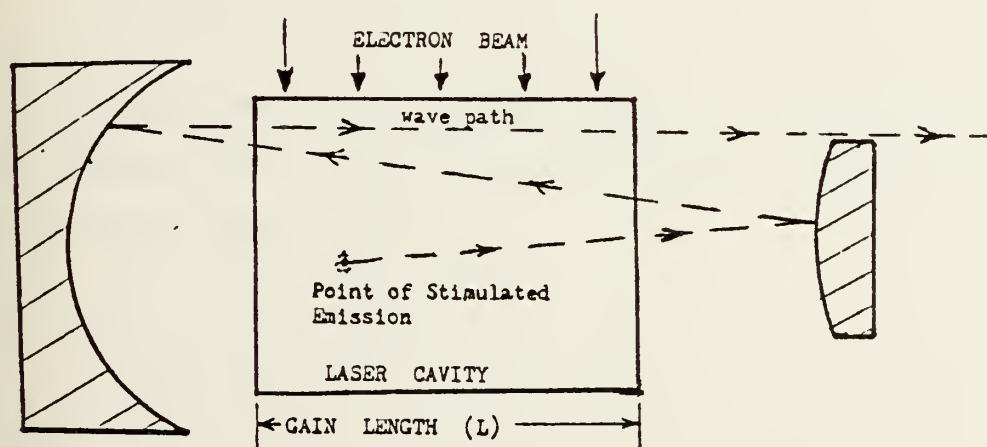
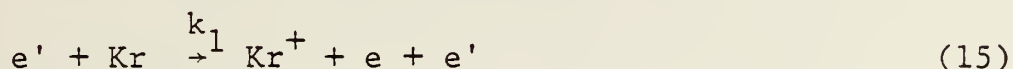
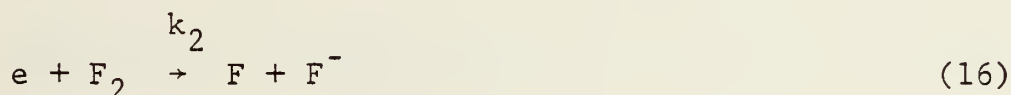


Figure 3. Example of e-beam pumped KrF laser geometry.

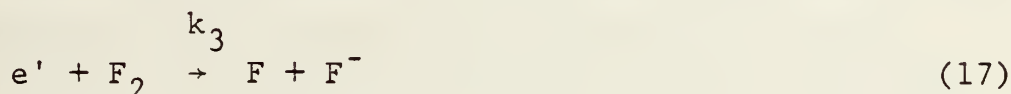
The first step in the kinetics chain leading to extraction of laser radiation is the deposition of energy in the diluent gas by either photons or electrons. In this model electrons are used. The electrons ionize the Kr and dissociate the F_2



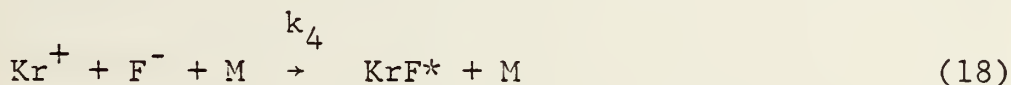
where e' is a primary electron, e is a secondary electron resulting from ionization of Kr, and k_1 is the forward rate constant. The secondary electron has sufficient energy to dissociate and electronegatively attach to atomic F.



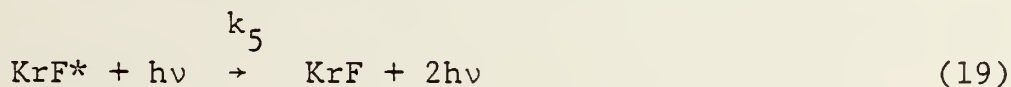
In addition dissociation of F_2 by the primary electrons occurs.



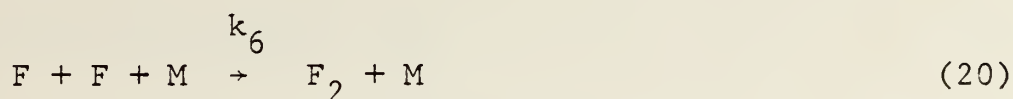
Having produced the ion pair states, recombination of positive rare gas ions and readily formed halide ions yields the excited state (KrF^*).



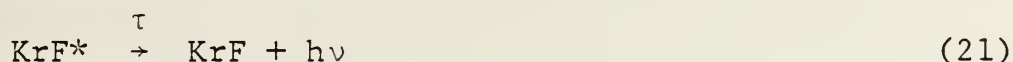
The KrF^* can produce a photon by stimulated emission.



Also, recombination of F can occur

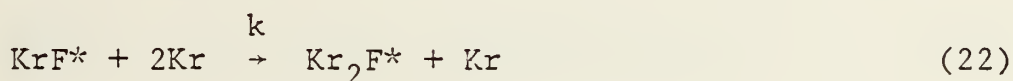


Fluorescence decreases KrF* population by



where τ is the radiative lifetime.

Reactions (15) to (21) are the only reactions considered in this model. None of the quenching processes of KrF* have been considered, such as



nor have many other reactions [2] and [28].

The reactions considered in this model are used to find the formation terms equation (13) and depletion terms equation (14). For example, examining reaction (15) the formation term for the concentration of e and Kr^+ is determined.

$$\text{Formation } e = k_1[e'][Kr] \quad (23)$$

$$\text{Formation } Kr^+ = k_1[e'][Kr] \quad (24)$$

where [] denote concentration in specie number/cm³.

The depletion term for concentration of e from reaction (16) is

$$\text{Depletion } e = k_2[e][F_2] \quad (25)$$

and for Kr^+ from reaction (18)

$$\text{Depletion } Kr^+ = k_4[Kr^+][F^-][M] \quad (26)$$

Applying equation (12), that is, equating the rate of change of e concentration to the sum of contributing formation terms equation (23) less the sum of depletion terms equation (25) yields

$$\frac{d[e]}{dt} = k_1[e'][Kr] - k_2[e][F_2] \quad (27)$$

Similarly, combining equations (24) and (26)

$$\frac{d[Kr^+]}{dt} = k_1[e'][Kr] - k_4[Kr^+][F^-][M] \quad (28)$$

Continuing the process

$$\frac{d[F]}{dt} = k_2[e][F_2] + k_3[e'][F_2] - k_6[F][M] \quad (29)$$

$$\frac{d[F]}{dt} = k_2[e][F_2] + k_3[e'][F_2] - k_4[Kr^+][F^-][M] \quad (30)$$

$$\frac{d[KrF^*]}{dt} = k_4[Kr^+][F^-][M] - k_5[h\nu][KrF^*] - [KrF^*]/\tau \quad (31)$$

$$\frac{d[KrF]}{dt} = k_5[KrF^*][h\nu] + [KrF^*]/\tau \quad (32)$$

are obtained.

In reaction (15) the e' is the e -beam input and therefore is a function of time. The model assumes the

concentration of e' is initially $1.0E13$ electrons/cm³ then becomes zero after about 177 nanoseconds. The secondary electron mean energy is 10 eV.

The rate constants (k) for the reactions were taken from scientific articles [2, 29, and 30] or derived as in the case of k_5 . The values of the rate constants are listed in Table II. The radiative lifetime, τ , is equal to 15 nanoseconds from reference [2].

Table II. Rate Constants

Rate Constant	Value	Reference
k_1	$5.0E-09$ cm ³ /sec	29
k_2	$2.0E-09$ cm ³ /sec	30
k_3	$5.0E-10$ cm ³ /sec	30
k_4	$1.0E-25$ cm ⁶ /sec	2
k_5	$1.5E-05$ cm ³ /sec	Derived in Appendix B
k_6	$1.0E-31$ cm ⁶ /sec	2

Equations (27) to (32) can be solved to calculate the concentrations as a function of time. Multiplying these equations by dt yields a form for numerical solution on the HP9830. Equations (27) to (32) become

$$d[e] = (k_1[e'][Kr] - k_2[e][F_2])dt \quad (33)$$

$$d[Kr] = (k_1[e'][Kr] - k_4[Kr^+][F^-][M])dt \quad (34)$$

$$d[F] = (k_2[e][F_2] + k_3[e'][F_2] - k_6[F][M])dt \quad (35)$$

$$d[F^-] = (k_2[e][F_2] + k_3[e'][F_2] - k_4[Kr^+][F^-][M])dt \quad (36)$$

$$d[KrF^*] = (k_4[Kr^+][F^-][M] - k_5[h\nu][KrF^*] - [KrF^*]/\tau)dt \quad (37)$$

$$d[KrF] = (k_5[KrF^*][h\nu] + [KrF^*]/\tau)dt \quad (38)$$

respectively.

The initial conditions for the set of equations are:

$$[e] = 0 \quad (39)$$

$$[F] = 0 \quad (40)$$

$$[F^-] = 0 \quad (41)$$

$$[Kr^+] = 0 \quad (42)$$

$$[KrF] = 0 \quad (43)$$

$$[KrF^*] = 0 \quad (44)$$

Several constants are specified as follows:

$$[h\nu] = 4.0E11 \text{ (calculated in Appendix C)} \quad (45)$$

$$[F_2] = 4.0E16 \quad (46)$$

$$[Kr] = 5.4E17 \quad \left. \begin{array}{l} \text{Assumed values for} \\ \text{the He/Kr/F}_2 \text{ mixture} \end{array} \right\} \quad (47)$$

$$[He] = 3.0E19 \quad \left. \begin{array}{l} (98.1/1.77/0.13) \text{ at} \\ \text{STP.} \end{array} \right\} \quad (48)$$

$$\text{Initial } T = 0$$

$$\text{Final } T = 250 \text{ nanoseconds}$$

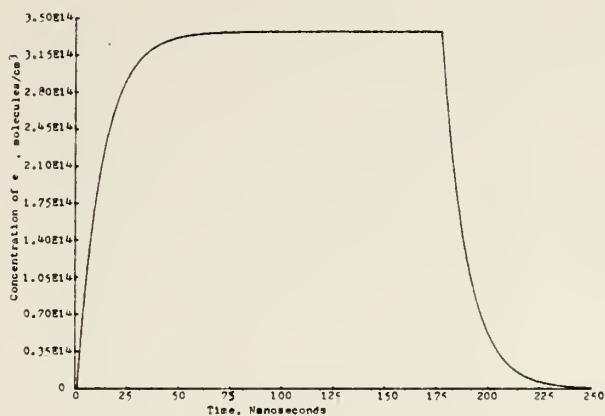
$$\Delta T = (\text{Final } T - \text{Initial } T)/256$$

A computer program was written using equations (33) to (38) and the initial conditions and appropriate constants given by equations (39) to (48). Figures 4 and 5, which are plots obtained from the HP9830 program, are the concentrations

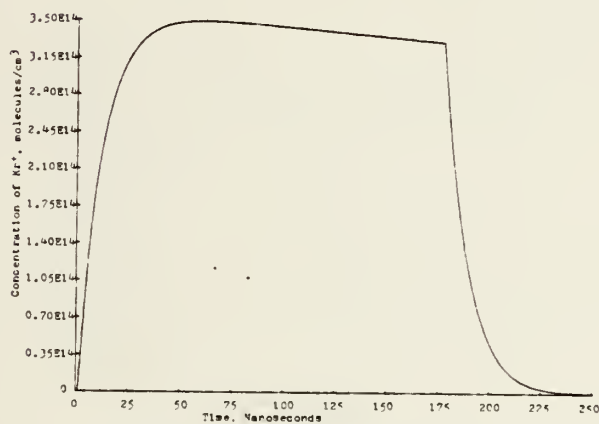
in specie number/cm³ versus time from 0 to 250 nanoseconds. The plots in Figures 4 and 5(b) indicate that some species densities rise extremely steeply in the first tenth of the simulation time; later in the pulse (after about 50 nanoseconds) species densities tend to flatten out. See Figure 4. Once the e-beam terminates, the decay time is approximately 50 nanoseconds. In Figure 5(a) and (b) other species densities increase gradually and flatten out. The results of this model are in qualitative agreement with the NRL simulation contained in reference [26]. The NRL simulation limited the change in concentration to 5 percent per time-step to obtain sufficient accuracy [26]. The question of timesteps for the simple model was avoided; sufficiently small steps were used throughout the program.

Table III lists the variables, symbols, and equations used in HP9830 computer program.

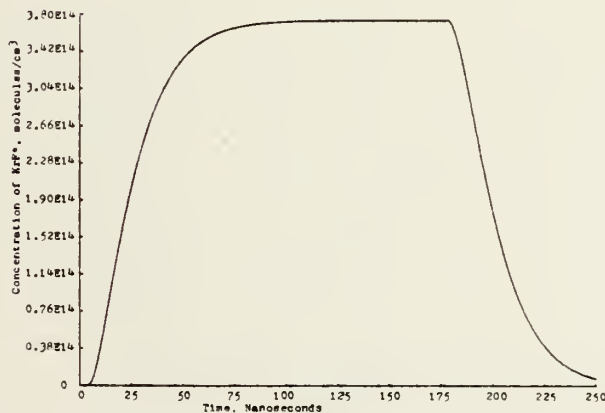
Table IV lists the KrF Computer Program and Table V lists the output.



(a) Concentration of secondary electrons

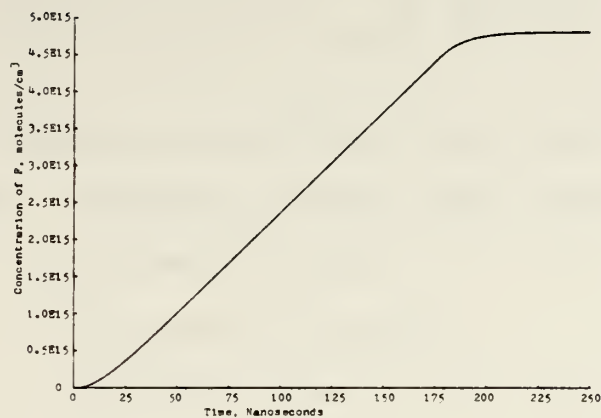


(b) Concentration of Kr^+

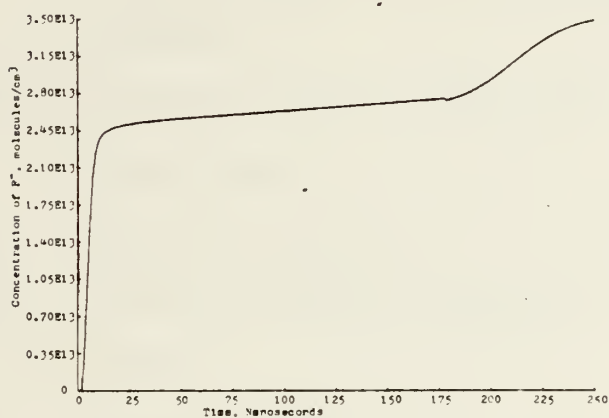


(c) Concentration of KrF^*

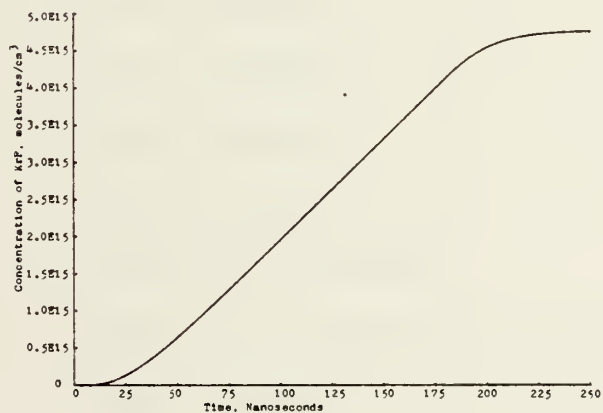
Figure 4. Concentration of secondary electrons (e), Kr^+ and KrF^* , molecules/ cm^3 , as a function of time.



(a) Concentration of F



(b) Concentration of F⁻



(c) Concentration of KrF

Figure 5. Concentration of F, F⁻, and KrF molecules/cm³, as a function of time.

Table III. Variables, Symbols, and Equations Used in HP9830 Computer Program for KrF Laser.

<u>Variables and Symbols Used in the Program</u>			
<u>HP9830</u>	<u>Text</u>	<u>Meaning or Value (for constants)</u>	<u>Units</u>
E1	e'	primary electron	-
E	e	secondary electron	-
F	F	Fluorine atom	-
G	F ₂	Fluorine molecule	-
H	F ⁻	Fluorine atom with extra electron	-
K	Kr	Krypton	-
L	Kr ⁺	Krypton minus an electron	-
M	M	Third body	-
X	KrF	Krypton Fluoride	-
Y	KrF*	Krypton Fluoride excited	-
P	hν	photon	joules
K1	k ₁	Rate constant	cm ³ /sec
K2	k ₂	Rate constant	cm ³ /sec
K3	k ₃	Rate constant	cm ³ /sec
K4	k ₄	Rate constant	cm ⁶ /sec
K5	k ₅	Rate constant	cm ³ /sec
K6	k ₆	Rate constant	cm ⁶ /sec
T1	τ	Radiative lifetime	sec
I	-	Index; I=1 for initial conditions	-
T	t	Time increment	sec

Table III (Continued). Variables, Symbols, and Equations
Used in HP9830 Computer Program for KrF Laser.

Equations Used in the Program

Line Number	Equation Number
860	33
870	34
880	35
890	36
900	45
910	37
920	38

```

10 FORMAT 7E10.3
20 DIM EC(256),FC(256),HC(256),LC(256),YC(256),XC(256)
30 DIM GC(256),AC(256),KC(256),MC(256),PC(256)
40 PRINT "PROGRAM FOR COUPLED KINETIC EQUATIONS FOR THREE ELEMENT GAS LASER"
50 PRINT " * * * * * "
60 PRINT "THIS PROGRAM IS FOR HP9830"
70 PRINT "A PRIMARY ELECTRON"
80 PRINT "E SECONDARY ELECTRON"
90 PRINT "F FLUORINE"
100 PRINT "G FLUORINE SUB 2"
110 PRINT "H FLUORINE MINUS"
120 PRINT "K KRYPTON"
130 PRINT "L KRYPTON PLUS"
140 PRINT "M THIRD BODY (DILUENT E.G. HELIUM)"
150 PRINT "X KRYPTON FLUORIDE"
160 PRINT "Y KRYPTON FLUORIDE EXCITED"
170 PRINT "P PRODUCT (PLANCK'S CONSTANT)*(FREQUENCY)"
180 PRINT "RATE CONSTANTS K1,K2,K3,K4,K5,K6"
190 T2=0
200 Z=0
210 PRINT "INPUT INITIAL CONDITIONS"
220 GOTO 950
570 DISP "T INITIAL=";
580 INPUT S
590 DISP "T FINAL =";
600 INPUT S9
610 S1=(S9-S)/256
620 T=S1
630 PRINT "E(1)="EC(1),"F(1)="FC(1),"H(1)="HC(1),"L(1)="LC(1),"X(1)="XC(1)
640 PRINT "Y(1)="YC(1),"P(1)="PC(1),"G(1)="GC(1)
650 PRINT "K(1)="KC(1),"M(1)="MC(1)
660 PRINT "A(1)="AC(1),"T1(RADIATIVE LIFETIME)="T1
670 PRINT "K1="K1,"K2="K2
680 PRINT "K3="K3,"K4="K4

```

Table IV. Listing of the HP9830 KrF Program


```

690 PRINT "K5="K5,"K6="K6
700 PRINT "INITIAL T="S,"FINAL T="S9
705 PRINT "DELTA T="T
710 PRINT
720 PRINT "CONCENTRATIONS AT TIME (T)"
730 PRINT "      TIME      E(SECONDARY)  F      F-      KR+      KRF*      KRF"
731 PRINT
735 WRITE (15,10)S,EL11,F111,H111,L111,Y111,X111
736 PRINT
740 FOR I=1 TO 256
750 IF I=256 THEN 1130
760 AL11=AL11
770 KL11=KL11
780 GL11=GL11
800 ML11=ML11
810 Z=Z+1
820 R=INT(Z/10)
830 V=ABS(R-Z/10)
840 IF V#0 THEN 860
850 WRITE (15,10)T2,EL11,F111,H111,L111,Y111,X111
855 PRINT
860 EL1+1]=EL11+(K1*AL11*(K11-K2*EL11)*GL11)*T
870 FL1+1]=FL11+(EL11*GL11*(K2+AL11*GL11)*K3-K6*FL11+2*ML11)*T
880 HL1+1]=HL11+(K2*EL11*GL11+K3*AL11*GL11-K4*LL11*HL11)*T
890 LL1+1]=LL11+(K1*AL11*(K11-K4*LL11)*HL11)*T
900 PL11=PL11
910 Y11+1]=Y111+(K4*LL11*HL11*ML11-K5*PL11*Y111/T1)*T
920 X11+1]=X111+(K5*Y111*PL11+Y111/T1)*T
930 T2=T2+T
935 IF I>180 THEN 941
940 NEXT I
941 AL11=0
942 GOTO 940
950 EL11=0

```

Table IV (Continued). Listing of the HP9830 KrF Program


```

960 FC1J=0
970 HC1J=0
980 LC1J=0
990 XC1J=0
1000 YC1J=0
1010 PC1J=4E+11
1020 GC1J=4E+16
1030 KC1J=5.4E+17
1040 MC1J=3E+19
1050 AC1J=1E+13
1055 T2=0
1060 T1=1.5E-08
1070 K1=5E-09
1080 K2=2E-09
1090 K3=5E-10
1100 K4=1E-25
1110 K5=1.5E-05
1115 K6=1E-31
1120 GOTO 570
1130 DISP "INPUT T9";
1140 INPUT T9
1150 DISP "INPUT C9";
1160 INPUT C9
1170 SCALE 0,T9,0,C9
1180 XAXIS 0,T9/10
1190 YAXIS 0,C9/10
1200 FOR I=1 TO 256
1210 T8=I*T
1220 PLOT T8,XC1J
1230 NEXT I
1240 PEN
1250 PRINT "CONT 1150"
1260 PRINT
1270 STOP
1350 END

```

Table IV (Continued). Listing of the HP9830 KrF Program


```

PROGRAM FOR COUPLED KINETIC EQUATIONS FOR THREE ELEMENT GAS LASER
* * * * *
THIS PROGRAM IS FOR HP9830
A PRIMARY ELECTRON
E SECONDARY ELECTRON
F FLUORINE
G FLUORINE SUB 2
H FLUORINE MINUS
K KRYPTON
L KRYPTON PLUS
M THIRD BODY (HE DILUENT
X KRYPTON FLUORIDE
Y KRYPTON FLUORIDE EXCITED
P PRODUCT (PLANCK'S CONSTANT)*(FREQUENCY)
RATE CONSTANTS K1,K2,K3,K4,K5,K6
INPUT INITIAL CONDITIONS
E(1)=0 F(1)=0 H(1)=0 L(1)=0 X(1)=0
Y(1)=0 P(1)=4.00000E+16 G(1)=4.00000E+16
K(1)=5.40000E+17 M(1)=3.00000E+19
A(1)=1.00000E+13 T1(RADIATIVE LIFETIME)=1.50000E-08
K1=5.00000E-09 K2=2.00000E-09
K3=5.00000E-10 K4=1.00000E-25
K5=1.50000E-05 K6=1.00000E-31
INITIAL T=0 FINAL T=2.50000E-07
DELTA T=9.76563E-10

```

Table V. Output of the HP9830 KrF Program

CONCENTRATIONS AT TIME (T)						
TIME	E(SECONDARY)	F	F-	KR+	KRF*	KRF
0.000E+00	0.000E+00	0.000E+00	0.000E+00	0.000E+00	0.000E+00	0.000E+00
8.789E-09	1.752E+14	6.386E+13	2.322E+13	1.967E+14	3.632E+13	4.318E+12
1.855E-08	2.655E+14	2.391E+14	2.487E+13	2.867E+14	1.482E+14	6.605E+13
2.832E-08	3.056E+14	4.647E+14	2.524E+13	3.252E+14	2.378E+14	2.017E+14
3.809E-08	3.234E+14	7.126E+14	2.545E+13	3.412E+14	2.963E+14	3.908E+14
4.785E-08	3.312E+14	9.703E+14	2.561E+13	3.473E+14	3.313E+14	6.134E+14
5.762E-08	3.347E+14	1.232E+15	2.576E+13	3.490E+14	3.512E+14	8.555E+14
6.738E-08	3.363E+14	1.496E+15	2.589E+13	3.487E+14	3.621E+14	1.109E+15
7.715E-08	3.370E+14	1.761E+15	2.603E+13	3.476E+14	3.679E+14	1.368E+15
8.691E-08	3.373E+14	2.027E+15	2.617E+13	3.460E+14	3.709E+14	1.630E+15
9.668E-08	3.374E+14	2.292E+15	2.631E+13	3.444E+14	3.725E+14	1.894E+15
1.064E-07	3.375E+14	2.557E+15	2.645E+13	3.426E+14	3.733E+14	2.158E+15
1.162E-07	3.375E+14	2.823E+15	2.659E+13	3.408E+14	3.737E+14	2.423E+15
1.260E-07	3.375E+14	3.088E+15	2.673E+13	3.390E+14	3.739E+14	2.688E+15
1.357E-07	3.375E+14	3.353E+15	2.687E+13	3.372E+14	3.740E+14	2.954E+15

Table V (Continued). Output of the HP9830 KrF Program

1.455E-07	3.375E+14	3.619E+15	2.702E+13	3.354E+14	3.741E+14	3.219E+15
1.553E-07	3.375E+14	3.884E+15	2.716E+13	3.336E+14	3.741E+14	3.485E+15
1.650E-07	3.375E+14	4.149E+15	2.731E+13	3.318E+14	3.741E+14	3.750E+15
1.748E-07	3.375E+14	4.414E+15	2.746E+13	3.300E+14	3.741E+14	4.016E+15
1.846E-07	1.761E+14	4.628E+15	2.773E+13	1.684E+14	3.300E+14	4.274E+15
1.943E-07	7.805E+13	4.725E+15	2.863E+13	7.133E+13	2.259E+14	4.475E+15
2.041E-07	3.460E+13	4.768E+15	2.993E+13	2.918E+13	1.376E+14	4.606E+15
2.139E-07	1.534E+13	4.787E+15	3.142E+13	1.141E+13	7.928E+13	4.683E+15
2.236E-07	6.800E+12	4.795E+15	3.281E+13	4.254E+12	4.246E+13	4.726E+15
2.334E-07	3.015E+12	4.798E+15	3.386E+13	1.523E+12	2.223E+13	4.749E+15
2.432E-07	1.337E+12	4.799E+15	3.455E+13	5.301E+11	1.133E+13	4.761E+15

Table V (Continued). Output of the HP9830 KrF Program

IV. XeF LASER COMPUTER PROGRAM FROM NRL

In order to calculate the excited states of neon in a XeF laser a complex kinetics program is required. A kinetics scheme for the XeF laser developed at the Naval Research Lab was used. It was written by Dr. Louis J. Palumbo [26 and 31] who assisted greatly in modifying it for use on the IBM 360/67.

The computer model consists of two parts: first, an e-beam deposition section, in which the kinetic energy of near relativistic electrons is used to ionize and excite the laser gas, and, second, a chemical kinetics section, in which the energy deposited in the gas cascades down by various processes to the upper laser level and is extracted as laser radiation.

One input to the NRL computer model is a list of reactions, e.g. in the format of equations (16) to (21). Also an input is a list of reaction rate coefficients. The computer program sorts the reactions and forms formation terms, F, and depletion terms, D. Formation and depletion terms were discussed earlier in connection with equations (13) and (14). Continuing, the computer program selects the appropriate F and D terms to form the rate equation of equation (12). Next, the computer program multiplies the rate equation by a variable timestep. The same approach was used in the simple computer program; see equations (33) to (38).

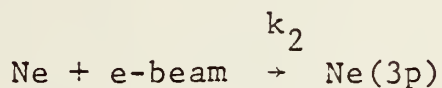
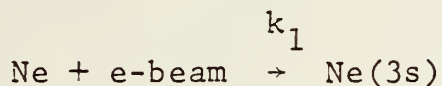
An advantage of the NRL program is the ability to change the number of reactions. The computer program does not change; only the input changes. The differential equations are generated internal to the program. This method makes it much easier to alter the set of equations and greatly reduces errors attendant to such alterations which arise with ease in the complex tangle of reactions. The detailed explanation of the computer model is contained in references [26] and [31]. Appendix A gives a list of reactions used to generate the population distribution within neon energy levels.

V. CALCULATION OF NEON EXCITED

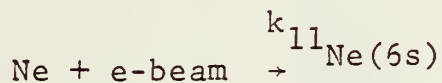
STATE POPULATIONS

The excited states of neon are represented in Figure 6. The electronic configurations of interest to this study are the 3s, 3p, 4s, 3d, 4p, 5s, 4d, 4f, 5p, 5d, and 6s.

In order to calculate the populations of these particular configurations, one needs to know the reactions involved and the rate constants. For example,



...



These reactions could then be input to the NRL XeF program to calculate the populations of the excited configurations of neon. After, an extensive literature search (Optics and Spectroscopy, The Journal of Chemical Physics, Applied Physics Letters, Physical Review A, Journal of the Optical Society of America, Chemical Abstracts, IEEE Journal of Quantum Electronics, etc.) rate constants for the individual excited configurations i.e. 3s, 3p, ... were not found.

Therefore, it was necessary to make a number of assumptions. The procedure followed was to extract all reactions

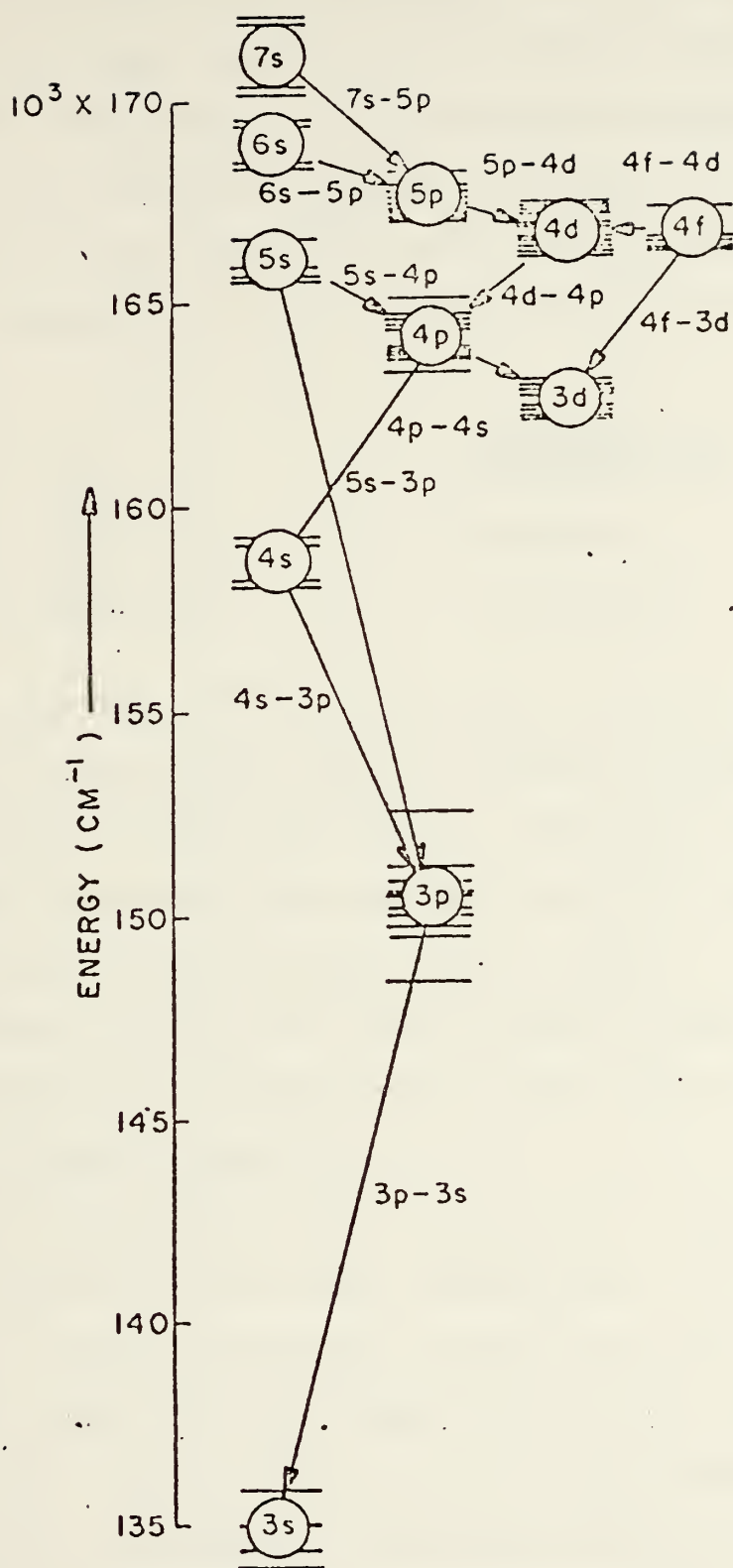


Figure 6. Energy-Level diagram of Neon (Reproduced from Pressley [32]).

from the NRL program involving the neon excited state (Ne*). Then, these reactions were subdivided into two groups, the Ne(3s) and all higher configurations, which are denoted by NE*1 and NE*Z respectively. The population distribution within NE*Z was calculated assuming a Boltzmann distribution.

The list of reactions which were used as modified input to the NRL program are listed in Table VI in the following format:

	<u>Rate Constant</u>	
Ne + e' → Ne* + e'	1.20E-18	(49)
Ne + e' → Ne*1 + e'	0.925E-18	(50)
Ne + e' → Ne*Z + e'	0.275E-18	(51)

To compare equations (49) to (51) with the first three reactions of Table VI note that e' is EBEM in FORTRAN notation. The other symbols are obvious. The first reaction yielding Ne* is divided into the Ne*1 and Ne*Z reactions. A computer run with the current density equal to 10 A/cm² and a computer run with the current density equal to 11 A/cm² calculated the populations for Ne*1 (3s) and Ne*Z (all levels greater than 3s).

The rate constants for the reactions were determined by taking a fraction of the total rate constant. For example, in Table VI, for the second set of reactions, the rate constant for NE*1 is 0.8 and NE*Z is 0.2 of the rate constant for NE*. These fractions of the rate constant for NE* are noted in parentheses following the reactions. The choices of the fractional values were arbitrary.

TABLE VI. Input Reactions to the NRL Program.*

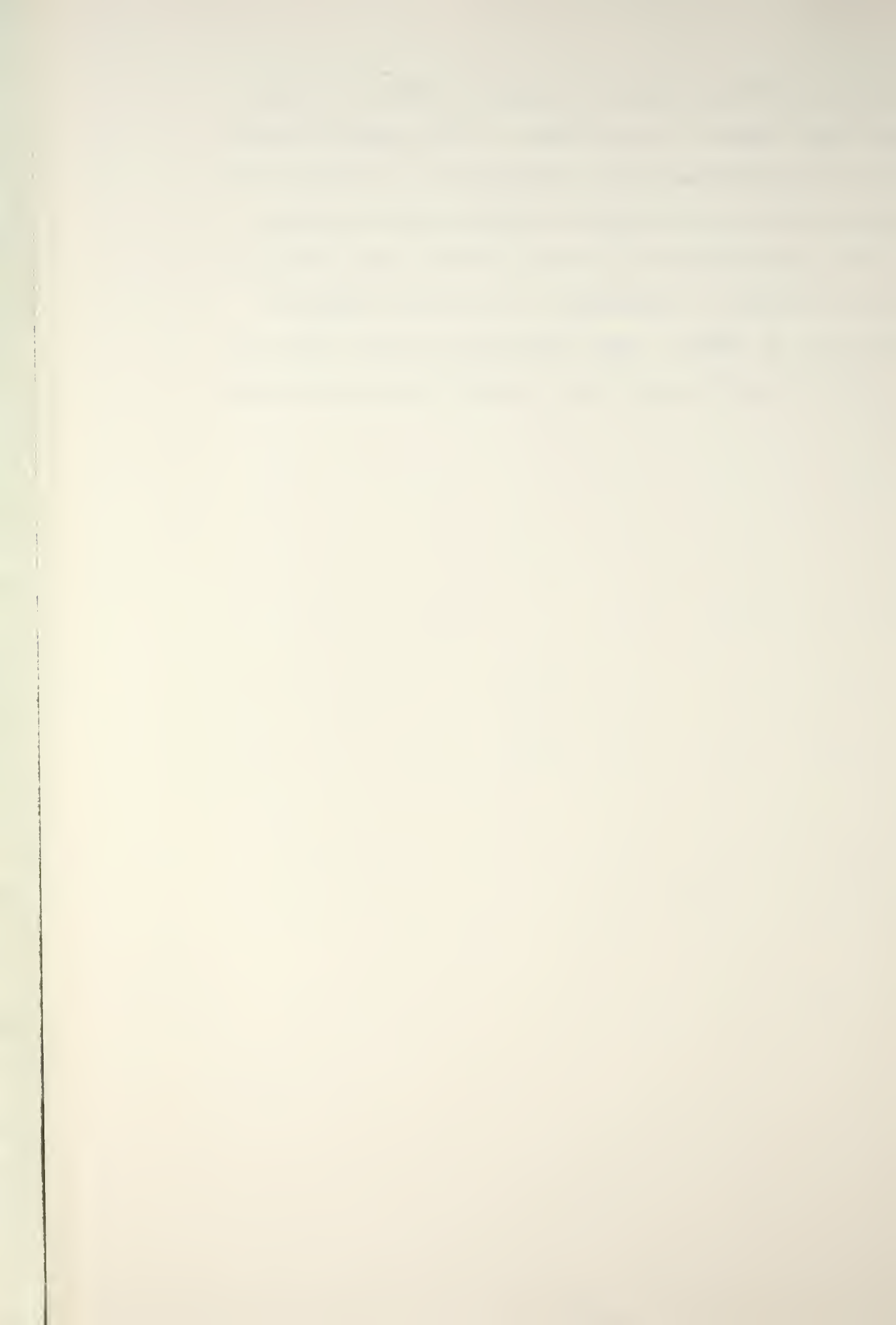
Reaction					Rate Constant
NE	+ EBEM	→ NE*	+ EBEM		1.20 E-18
NE	+ EBEM	→ NE*1	+ EBEM		0.925E-18
NE	+ EBEM	→ NE*Z	+ EBEM		0.275E-18
NE*	+ E-	→ NE	+ E-		2.00 E-10
NE*1	+ E-	→ NE	+ E-	(.8)	1.60 E-10
NE*Z	+ E-	→ NE	+ E-	(.2)	0.40 E-10
NE2+	+ E-	→ NE*	+ NE		3.50 E-08
NE2+	+ E-	→ NE*1	+ NE	(.9)	3.15 E-08
NE2+	+ E-	→ NE*Z	+ NE	(.1)	0.35 E-08
NE3+	+ E-	→ NE*	+ NE	+ NE	3.50 E-08
NE3+	+ E-	→ NE*1	+ NE	+ NE	(.95) 3.325E-08
NE3+	+ E-	→ NE*Z	+ NE	+ NE	(.05) 0.175E-08
XENE+	+ E-	→ NE*	+ XE		6.00 E-08
XENE+	+ E-	→ NE*1	+ XE	(.6)	3.60 E-08
XENE+	+ E-	→ NE*Z	+ XE	(.4)	2.40 E-08
NE*	+ NE + NE	→ NE2*	+ NE		5.0 E-34
NE*1	+ NE + NE	→ NE2*	+ NE	(.8)	4.0 E-34
NE*Z	+ NE + NE	→ NE2*	+ NE	(.2)	1.0 E-34
NE*	+ XE	→ XE+	+ E-	+ NE	7.40 E-11
NE*1	+ XE	→ XE+	+ E-	+ NE	(.6) 4.44 E-11
NE*Z	+ XE	→ XE+	+ E-	+ NE	(.4) 2.96 E-11
NE*	+ XE	→ NEXE+	+ E-		2.20 E-11
NE*1	+ XE	→ NEXE+	+ E-	(.6)	1.32 E-11
NE*Z	+ XE	→ NEXE+	+ E-	(.4)	0.88 E-11

TABLE VI (Continued). Input Reactions to the NRL Program.*

<u>Reaction</u>				<u>Rate Constant</u>	
NE*	+ F2	→ NEF*	+ F		4.10 E-10
NE*1	+ F2	→ NEF*	+ F	(.8)	3.28 E-10
NE*Z	+ F2	→ NEF*	+ F	(.2)	0.62 E-10
NE*	+ NF3	→ NEF*	+ NF2		1.05 E-10
NE*1	+ NF3	→ NEF*	+ NF2	(.8)	0.84 E-10
NE*Z	+ NF3	→ NEF*	+ NF2	(.2)	0.21 E-10
NE*	+ NF2	→ NEF*	+ NF		1.0 E-10
NE*1	+ NF2	→ NEF*	+ NF	(.8)	0.8 E-10
NE*Z	+ NF2	→ NEF*	+ NF	(.2)	0.2 E-10
NE*	+ NF	→ NEF*	+ N		1.0 E-10
NE*1	+ NF	→ NEF*	+ N	(.8)	0.8 E-10
NE*Z	+ NF	→ NEF*	+ N	(.2)	0.2 E-10
NE2*	+ HN352L	→ NE*	+ NE + ABSL		1.0 E-18P
NE2*	+ HN352L	→ NE*	+ NE + ABSL	(.9)	0.9 E-18P
NE2*	+ HN352L	→ NE*	+ NE + ABSL	(.1)	0.1 E-18P

*Use of capital letters more closely represents computer printing.

However, the first reactions listed in Table VI do not have fractional values in parentheses, as the reaction rate constants were determined using reference [9]. The plot of "Excitation of Neon by Electrons" from page 467 of reference [9] was extrapolated to 10 keV, and the value for the $2p_1$ state was assumed to represent all excited configurations above the 3s (NE^*1). The difference between the rate constant for NE^* and the $2p_1$ value yielded the rate constant for NE^*1 .



VI. CALCULATION OF THE INDEX OF REFRACTION

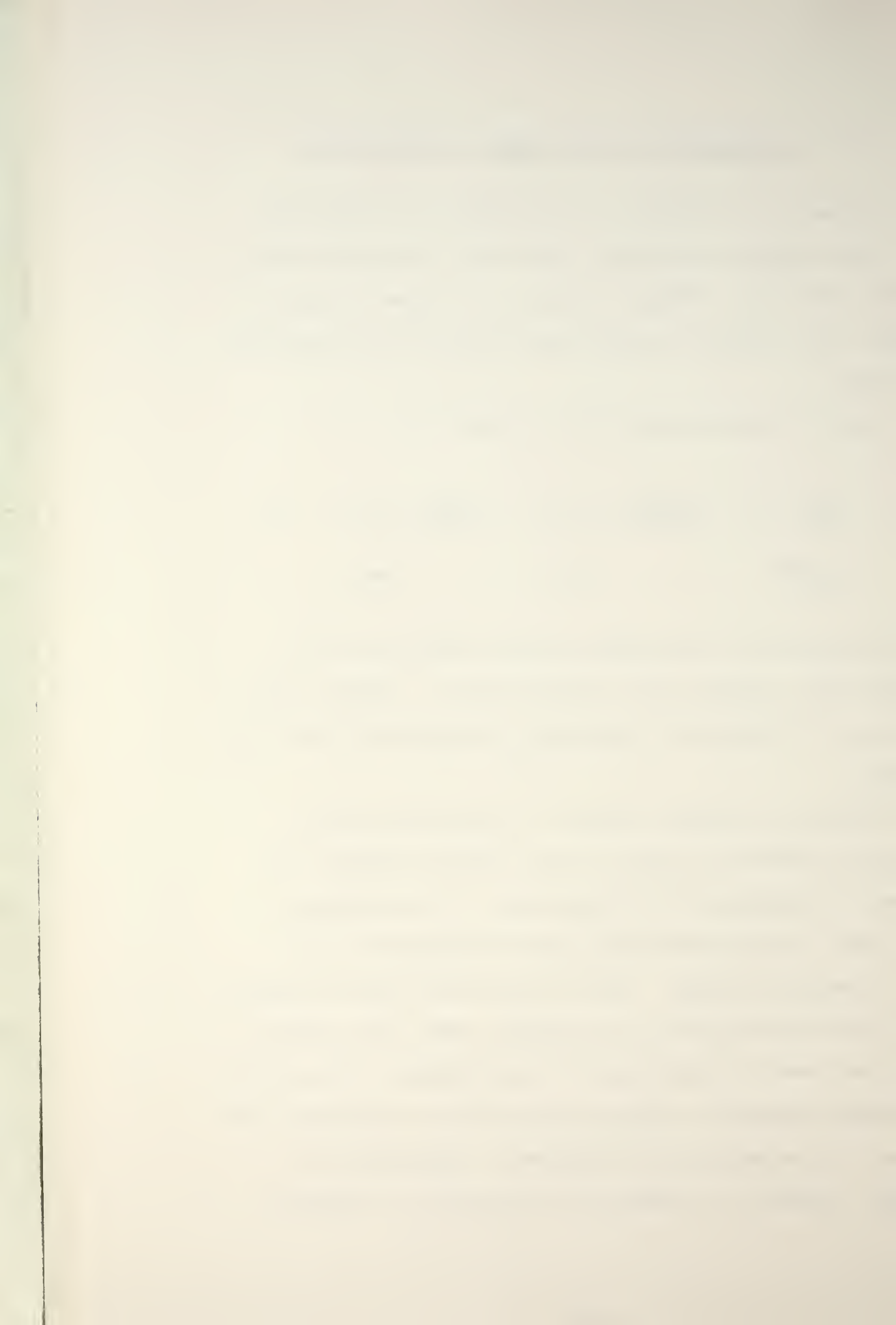
The values $(n-1)/N$ where n is the index of refraction and N is the species population, have been calculated Refs. [33], [34] and [35]. Figure 7 lists the values of $(n-1)/N$. References [34] and [35] contain the details of calculating these values.

The index of refraction $(n-1)$ is equal to

$$n-1 = \left(\frac{(n-1)}{N_{\text{ground state}}} \right) N + \left(\frac{(n-1)}{N_{\text{Ne*1}(3s)}} \right) N(3s) + \left(\frac{(n-1)}{N_{\text{Ne*Z}(Z)}} \right) N(Z) \quad (52)$$

Using the populations calculated in the NRL model for N , $N(3s)$, and $N(Z)$ equation (52) can be solved. However, the populations of individual electronic configurations must be determined.

One feature of excimer lasers, in contrast to the vibrational transition lasers of the infrared region, is the extent of randomness of populations. In the CO_2 gas dynamic laser, mode temperatures can be assigned to the various vibrational modes. Due to the short span of excitation and power extraction in an excimer laser, the various modes do not have an opportunity to equilibrate. This fact is the reason extensive computer programs are necessary for kinetics. An assumption of a Boltzmann distribution is unfounded. However, in view of the sparsity of reaction



		INITIAL CONFIGURATION															
		2p	3s	3p	4s	3d	4p	5s	4d	4f	5p	5d	6s				
FINAL CONFIGURATION	2p	E	-204		F	-26.7	E	-4.3	E	-8.8	E	-2.3	E	-1.2	E	-4.1	
	3s	A	408	E			E	R*			E						
	3p			29,160	E	33,316	E	39,029	E	3,890	E	4,774	E	1,744	E	1,558	
	4s	A			A				E								
	3d	A	53.3	-11,105													
	4p	A	43.8	-65,049	A			12	E								
	4d	A	R*		A	-90,034	A	-7,695	E	55,186	E	38,039	E	5,051	E	4,679	
	5s	A		-1,297													
	4f	A	22.9	-7,958	A			-63,398	E								
	5p				A												
5d	A		-2,906	A	-1,977	A	-5.3	A	-113,985	A	-14,994	E	42,005	E	78,005		
6s	A		-519					A									
558			-87,444	-59,674	-58,722	31,324	-61,758	-54,918	27,817		-32,435	42,799				64,236	
R* resonance - requires special attention																	

R* resonance - requires special attention

Figure 7. Matrix of significant configuration arrays. The number in the blocks is $(n-1)/N \text{ cm}^3$ multiplied by 1027 (Reproduced from Fuhs, Etchecury, and Cole [33]).

rate coefficients for excitation to specific configurations a Boltzmann distribution is assumed. Assuming a Boltzmann relation for the upper levels the populations of the 3p, 4s, 3d, ... 6s can be calculated.

$$N(Z) = N(3p) + N(4s) + N(3d) + \dots + N(6s) \quad (53)$$

$$N(Z) = N(3p) \left[1 + \frac{g_{4s}}{g_{3p}} \exp \frac{-(E_{4s} - E_{3p})}{kT} + \frac{g_{3d}}{g_{3p}} \exp \frac{-(E_{3d} - E_{3p})}{kT} \dots \right] \quad (54)$$

where g denotes the degeneracy of the configuration which is equal to the sum of the $2J + 1$ terms. E is the energy subscripted by the configuration.

Solving for $N(3p)$

$$N(3p) = \frac{N(Z)}{1 + \frac{g_{4s}}{g_{3p}} \exp \frac{-(E_{4s} - E_{3p})}{kT} + \dots} \quad (55)$$

All the quantities on the right side of equation (55) are known or can be calculated. Table VII lists the values of the degeneracies and energies for the configurations.

TABLE VII. Degeneracy and energy values for the configurations.

<u>Electronic Configuration</u>	<u>$g(\sum 2J + 1)$</u>	<u>$E \text{ (cm}^{-1}\text{)}$</u>
3s	12	134674.6
3p	36	150197.8
4s	12	158950.1
3d	73	161874.4
4p	36	163180.3
5s	12	166123.2
4d	73	166500
4f	84	166562
5p	36	167812.5
5d	73	168000 .
6s	12	168750

The temperature T is calculated as follows using the Boltzmann relation

$$\frac{N(3s)}{N(2p)} = \frac{g_{3s}}{g_{2p}} \exp \frac{-(E_{3s} - E_{2p})}{kT} \quad (56)$$

Solving for T

$$\ln \left[\frac{N(3s)}{N(2p)} \frac{g_{2p}}{g_{3s}} \right] = \frac{-(E_{3s} - E_{2p})}{kT}$$

$$T = \frac{-(E_{3s} - E_{2p})}{k \ln \left[\frac{N(3s) g_{2p}}{N(2p) g_{3s}} \right]} \quad (57)$$

Substituting the value of T into equation (55) yields a value for N(3p). To calculate N(4s) one uses

$$N(4s) = N(3p) \frac{g_{4s}}{g_{3p}} \exp \left[\frac{-(E_{4s} - E_{3p})}{kT} \right] \quad (58)$$

Similarly the populations of the other configurations can be calculated i.e. N(3d), N(4p), etc. Once the populations of the configurations have been found it is a simple calculation to obtain n-1 applying equation (52) as

$$\frac{n-1}{Ne(3p)}, \frac{n-1}{Ne(4s)}, \dots, \frac{n-1}{Ne(6s)}$$

are given along the bottom of Figure 7.

A computer program to calculate the index of refraction (n-1) using equations (52), (55), (57), and (58) was written.

In Figure 7 the 3s → 4p transition contains an R*. R* indicates that resonance may occur and can have a large effect on the index of refraction. The spikes in Figure 8 are located at the resonant wavelengths. Resonance is discussed in reference [36].

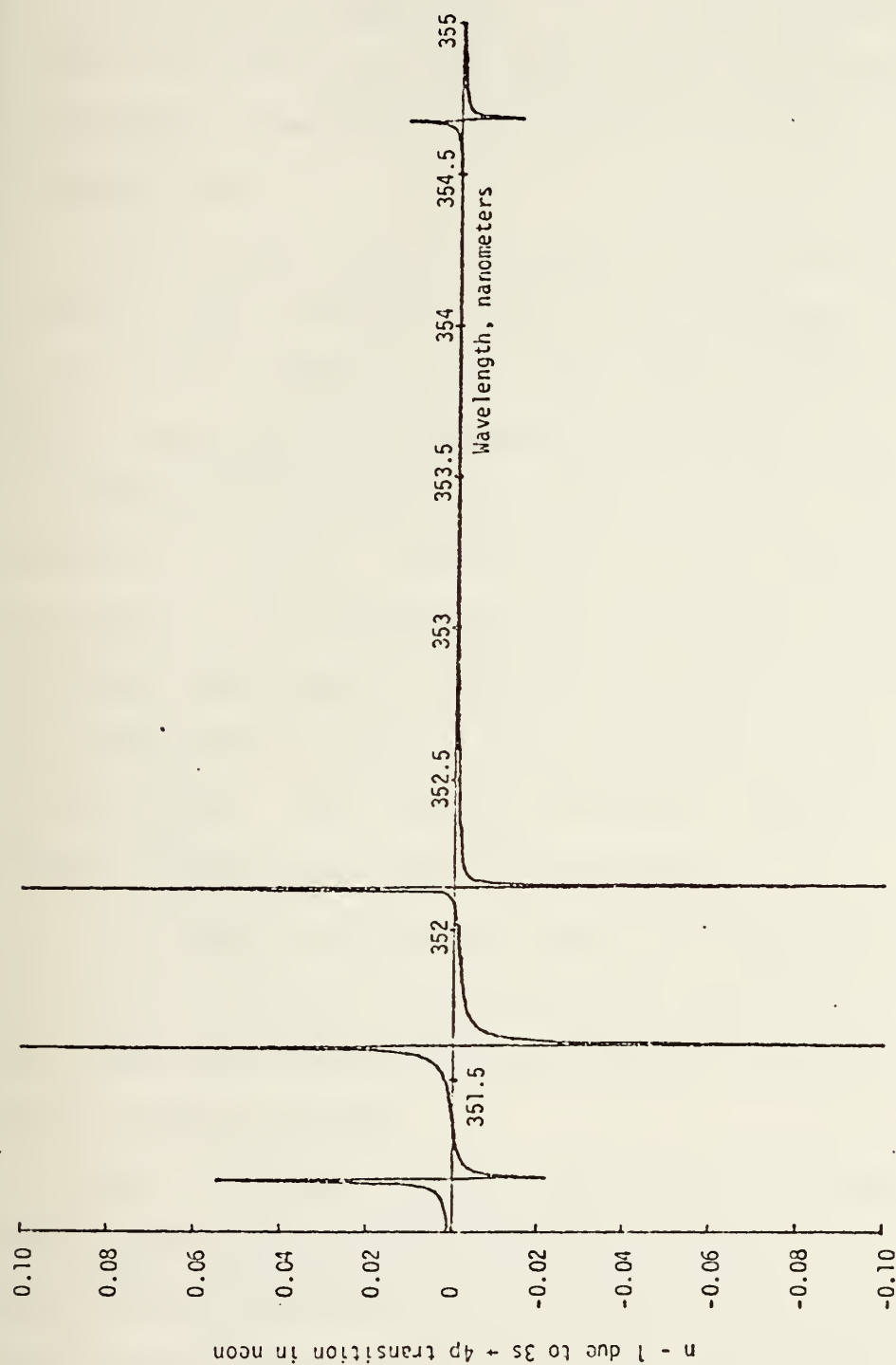


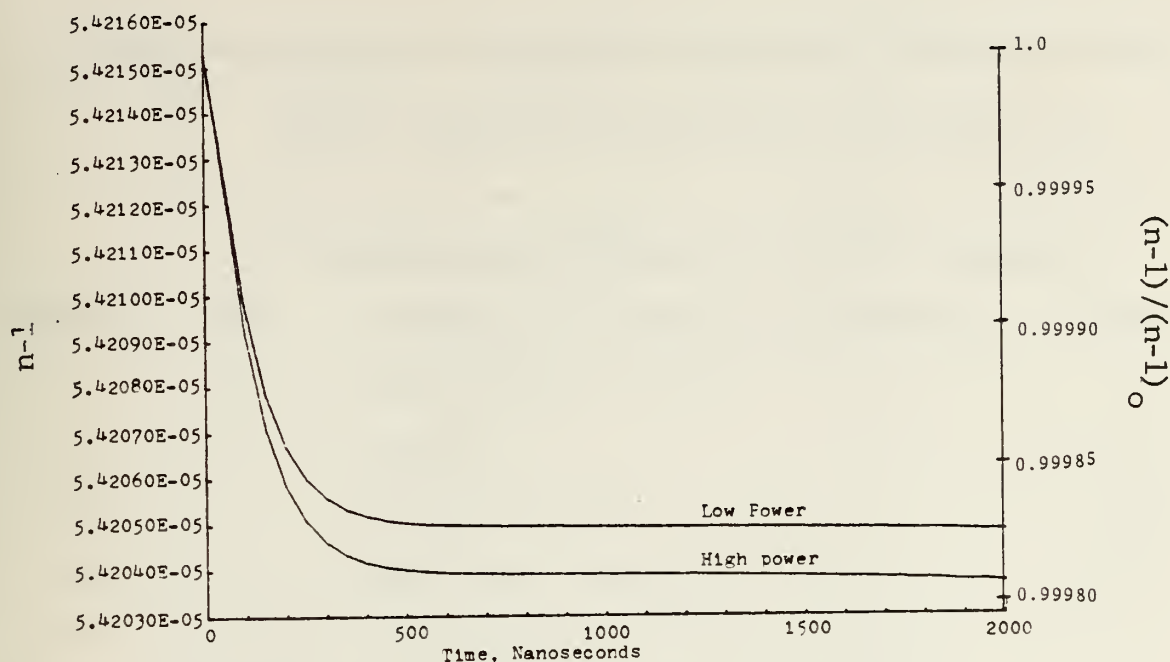
Figure 8. Plot of $n-1$ as a function of wavelength. The quantity plotted is contribution of $3s \rightarrow 4p$ transition in neon (Reproduced from Fuhs, Etchechury, and Cole [36]).

The plots in Figure 9 are of the calculated indices of refraction $(n-1)$ versus time (nanoseconds). Figure 9(a) is for a laser wavelength away from $3s \rightarrow 4p$ (no resonance) for both low and high power. The current density for low power is 10 A/cm^2 , and the high power is 11 A/cm^2 . For a nonresonant wavelength, the change in $n-1$ is in the fourth decimal place.

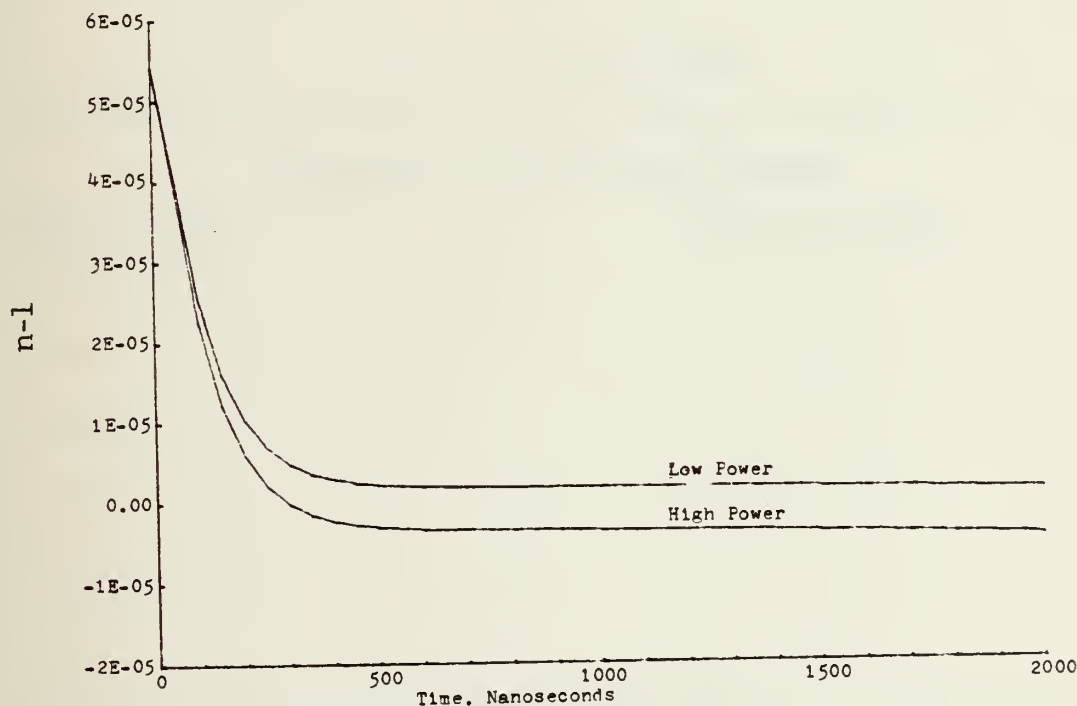
The resonance effect was taken into account in a second computer run; see Figure 9(b). For a resonant laser wavelength, the contribution to the index of refraction due to $\text{Ne}(3s)$ was calculated assuming $(n-1)/\text{Ne}(3s)$ equal to $-5.0\text{E}08$; the corresponding value for $\text{Ne}(4p)$ was $(n-1)/\text{Ne}(4p)$ equal to $1.667\text{E}08$. Figure 9(b) is for a laser wavelength near the $3s \rightarrow 4p$ resonance for low and high power. The resonance has a marked effect on the index of refraction in comparison to Figure 9(a) as evidenced by the ordinates of the plots. Also, Figure 9 reveals that increasing the power decreases the index of refraction.

The right hand ordinate scale for Figure 9(a) is the ratio $(n-1)/(n-1)_0$, where $(n-1)_0$ is the value at zero time. The scale emphasizes the fact that the relative changes are in the fourth decimal.

Table VIII lists the variables, symbols, and equations used in the HP9830 program to calculate $n-1$. Table IX lists the HP9830 program used to calculate $n-1$ and Tables X and XI list sample output for low and high power respectively.



(a) Index of refraction ($n-1$) at laser wavelength away from $3s \rightarrow 4p$ resonance for high and low power.



(b) Index of refraction ($n-1$) at laser wavelength near $3s \rightarrow 4p$ resonance for high and low power.

Figure 9. Calculated index of refraction ($n-1$) as a function of time.

TABLE VIII. Variables, Symbols, and Equations Used in HP9830 Computer Program for Calculation of $n-1$.

<u>Variables and Symbols Used in the Program</u>			
<u>HP9830</u>	<u>Text</u>	<u>Meaning or Value (for constants)</u>	<u>Units</u>
G	g	degeneracy ($\Sigma 2J+1$)	-
E	E	energy	cm^{-1}
C1	c	speed of light	cm/sec
K2	k	Boltzmann constant	$\text{eV}/^\circ\text{K}$
M	$n-1/\text{Ne}()$	Contribution of excited state	-
K	2p, 3s, ...	Index of the levels 1 to 12	-
K()	T	Temperature	degrees Kelvin
J	-	Time increment index	-

<u>Equations Used in the Program</u>	
<u>Line Number</u>	<u>Equation Number</u>
320	57
930	56
1030	54
1060	55
1130	53
1350	52

TABLE IX. Listing of the HP9330 Index of Refraction (n-1) Program.

```

10 PRINT "                LOW POWER 10A/CM+2"
20 PRINT
100 DATA 0,9.716E+19,1E-50,1E-50
110 DATA 50,9.716E+19,2.85E+13,1.166E+13
120 DATA 100,9.716E+19,5.814E+13,2.802E+13
130 DATA 150,9.716E+19,7.709E+13,4.034E+13
140 DATA 200,9.716E+19,8.868E+13,4.843E+13
150 DATA 250,9.716E+19,9.572E+13,5.35E+13
160 DATA 300,9.716E+19,9.998E+13,5.661E+13
170 DATA 350,9.716E+19,1.026E+14,5.851E+13
180 DATA 400,9.716E+19,1.041E+14,5.966E+13
190 DATA 450,9.716E+19,1.051E+14,6.035E+13
200 DATA 500,9.716E+19,1.057E+14,6.077E+13
210 DATA 550,9.716E+19,1.06E+14,6.103E+13
220 DATA 600,9.716E+19,1.062E+14,6.118E+13
230 DATA 650,9.716E+19,1.063E+14,6.127E+13
240 DATA 700,9.716E+19,1.064E+14,6.132E+13
250 DATA 750,9.716E+19,1.065E+14,6.135E+13
260 DATA 800,9.716E+19,1.065E+14,6.137E+13
270 DATA 850,9.716E+19,1.065E+14,6.138E+13
280 DATA 900,9.716E+19,1.066E+14,6.139E+13
290 DATA 950,9.716E+19,1.066E+14,6.14E+13
300 DATA 1000,9.716E+19,1.066E+14,6.14E+13
310 DATA 1050,9.716E+19,1.066E+14,6.14E+13
320 DATA 1100,9.716E+19,1.067E+14,6.14E+13
330 DATA 1150,9.716E+19,1.067E+14,6.141E+13
340 DATA 1200,9.716E+19,1.067E+14,6.141E+13
350 DATA 1250,9.716E+19,1.067E+14,6.141E+13
360 DATA 1300,9.716E+19,1.068E+14,6.142E+13
370 DATA 1350,9.716E+19,1.068E+14,6.142E+13
380 DATA 1400,9.716E+19,1.069E+14,6.143E+13
390 DATA 1450,9.716E+19,1.069E+14,6.144E+13
400 DATA 1500,9.716E+19,1.07E+14,6.145E+13
410 DATA 1550,9.716E+19,1.07E+14,6.146E+13
420 DATA 1600,9.716E+19,1.071E+14,6.147E+13
430 DATA 1650,9.716E+19,1.072E+14,6.148E+13
440 DATA 1700,9.716E+19,1.073E+14,6.149E+13
450 DATA 1750,9.716E+19,1.074E+14,6.15E+13
460 DATA 1800,9.716E+19,1.074E+14,6.152E+13
470 DATA 1850,9.716E+19,1.075E+14,6.153E+13
480 DATA 1900,9.716E+19,1.077E+14,6.155E+13
490 DATA 1950,9.716E+19,1.078E+14,6.157E+13
500 DATA 2000,9.716E+19,1.079E+14,6.159E+13
510 DIM TC[41],KC[41],SC[41],ZC[41],MC[13],GC[13]
515 DIM RC[41,12],LC[41],HC[41],EC[13],AC[41,12],NC[41,12]

```


TABLE IX (Continued). Listing of the HP9830 Index of Refraction (n-1) Program.

```

510 Y=0
520 G[1]=1
530 G[2]=G[4]=G[7]=G[12]=12
540 G[3]=G[6]=G[10]=36
550 G[5]=G[8]=G[11]=73
560 G[9]=84
570 E[1]=0
580 E[2]=134674.61
590 E[3]=150197.81
600 E[4]=158950.1
610 E[5]=161874.4
620 E[6]=163180.29
630 E[7]=166123.23
640 E[8]=166500
650 E[9]=166562
660 E[10]=167812.5
670 E[11]=168000
680 E[12]=168750
690 K2=8.6171E-05
691 C1=2.997925E+10
692 H=4.1356E-15
693 C2=C1*H
700 C=1E-27
705 Y=Y+1
710 FOR J=1 TO 41
720 READ T[J],N[J,1],N[J,2],Z[J]
730 NEXT J
740 FOR J=1 TO 41
770 NEXT J
790 FOR J=1 TO 41
800 Q=N[J,2]*G[1]/(N[J,1]*G[2])
810 Q=LOGQ
820 K[J]=-((E[2]-E[1])*C2)/(Q*K2)
850 NEXT J
880 FOR J=1 TO 41
900 FOR K=4 TO 12
910 Q1=((E[K]-E[3])*C2)/(K2*K[J])
920 Q1=EXP(-Q1)
930 A[J,K]=G[K]*Q1/G[3]
960 NEXT K
980 NEXT J
990 FOR J=1 TO 41
1000 S=1
1020 FOR K=4 TO 12
1030 S=S+A[J,K]
1040 NEXT K
1050 S[J]=S
1060 N[J,3]=Z[J]/S[J]
1090 NEXT J

```


TABLE IX (Continued). Listing of the HP9830 Index of Refraction (n-l) Program.

```

1100 FOR J=1 TO 41
1120 FOR K=4 TO 12
1130 N[J,K]=N[J,3]*R[J,K]
1160 NEXT K
1170 NEXT J
1210 M[1]=558
1220 M[2]=-87444
1230 M[3]=-59674
1240 M[4]=-58722
1250 M[5]=31324
1260 M[6]=-61758
1270 M[7]=-54918
1280 M[8]=27817
1290 M[9]=0
1300 M[10]=-32435
1310 M[11]=48799
1320 M[12]=84238
1330 FOR J=1 TO 41
1340 R=0
1350 FOR K=1 TO 12
1360 R[J,K]=M[K]*N[J,K]*C
1370 R=R+R[J,K]
1400 NEXT K
1412 IF Y=1 THEN 1418
1414 H[J]=R
1416 GOTO 1420
1418 L[J]=R
1420 PRINT "N - 1 IS "R"AT TIME "T[J]"NSEC"
1440 NEXT J
1450 PRINT
1460 PRINT "          HIGH POWER 11A/CM^2  "
1465 PRINT
1468 IF Y >= 2 THEN 1500
1470 GOTO 705
1500 SCALE 0,2000,-2E-05,6E-05
1510 XAXIS -2E-05,100
1520 YAXIS 0,1E-05
1530 FOR J=1 TO 41
1540 PLOT T[J],L[J]
1550 NEXT J
1560 PEN
1570 FOR J=1 TO 41
1580 PLOT T[J],H[J]
1590 NEXT J
1600 PEN
1610 STOP

```


TABLE IX (Continued). Listing of the HP9830 Index of Refraction (n-1) Program.

```

5000 PRINT "DATA FOR HIGH POWER 11A/CM+2"
5010 DATA 0,9.716E+19,1E-50,1E-50
5020 DATA 50,9.716E+19,3.136E+13,1.283E+13
5030 DATA 100,9.716E+19,6.398E+13,3.083E+13
5040 DATA 150,9.716E+19,8.486E+13,4.439E+13
5050 DATA 200,9.716E+19,9.762E+13,5.329E+13
5060 DATA 250,9.716E+19,1.054E+14,5.886E+13
5070 DATA 300,9.716E+19,1.101E+14,6.229E+13
5080 DATA 350,9.716E+19,1.129E+14,6.438E+13
5090 DATA 400,9.716E+19,1.147E+14,6.564E+13
5100 DATA 450,9.716E+19,1.157E+14,6.641E+13
5110 DATA 500,9.716E+19,1.163E+14,6.687E+13
5120 DATA 550,9.716E+19,1.167E+14,6.715E+13
5130 DATA 600,9.716E+19,1.17E+14,6.732E+13
5140 DATA 650,9.716E+19,1.171E+14,6.742E+13
5150 DATA 700,9.716E+19,1.172E+14,6.748E+13
5160 DATA 750,9.716E+19,1.173E+14,6.751E+13
5170 DATA 800,9.716E+19,1.173E+14,6.754E+13
5180 DATA 850,9.716E+19,1.173E+14,6.755E+13
5190 DATA 900,9.716E+19,1.174E+14,6.756E+13
5200 DATA 950,9.716E+19,1.174E+14,6.757E+13
5210 DATA 1000,9.716E+19,1.175E+14,6.757E+13
5220 DATA 1050,9.716E+19,1.175E+14,6.758E+13
5230 DATA 1100,9.716E+19,1.175E+14,6.758E+13
5240 DATA 1150,9.716E+19,1.176E+14,6.759E+13
5250 DATA 1200,9.716E+19,1.176E+14,6.76E+13
5260 DATA 1250,9.716E+19,1.177E+14,6.76E+13
5270 DATA 1300,9.716E+19,1.178E+14,6.671E+13
5280 DATA 1350,9.716E+19,1.178E+14,6.762E+13
5290 DATA 1400,9.716E+19,1.179E+14,6.763E+13
5300 DATA 1450,9.716E+19,1.18E+14,6.765E+13
5310 DATA 1500,9.716E+19,1.181E+14,6.766E+13
5320 DATA 1550,9.716E+19,1.182E+14,6.768E+13
5330 DATA 1600,9.716E+19,1.183E+14,6.769E+13
5340 DATA 1650,9.716E+19,1.184E+14,6.771E+13
5350 DATA 1700,9.716E+19,1.186E+14,6.773E+13
5360 DATA 1750,9.716E+19,1.187E+14,6.776E+13
5370 DATA 1800,9.716E+19,1.188E+14,6.778E+13
5380 DATA 1850,9.716E+19,1.19E+14,6.781E+13
5390 DATA 1900,9.716E+19,1.192E+14,6.784E+13
5400 DATA 1950,9.716E+19,1.192E+14,6.787E+13
5410 DATA 2000,9.716E+19,1.196E+14,6.791E+13
5420 END

```


TABLE X. Output of the HP9830 for n-1 at Low Power.

LOW POWER 10A/CM²

N - 1	IS	5.42153E-05	AT TIME	0	NSEC
N - 1	IS	5.42126E-05	AT TIME	50	NSEC
N - 1	IS	5.42097E-05	AT TIME	100	NSEC
N - 1	IS	5.42078E-05	AT TIME	150	NSEC
N - 1	IS	5.42067E-05	AT TIME	200	NSEC
N - 1	IS	5.42060E-05	AT TIME	250	NSEC
N - 1	IS	5.42056E-05	AT TIME	300	NSEC
N - 1	IS	5.42053E-05	AT TIME	350	NSEC
N - 1	IS	5.42052E-05	AT TIME	400	NSEC
N - 1	IS	5.42051E-05	AT TIME	450	NSEC
N - 1	IS	5.42050E-05	AT TIME	500	NSEC
N - 1	IS	5.42050E-05	AT TIME	550	NSEC
N - 1	IS	5.42050E-05	AT TIME	600	NSEC
N - 1	IS	5.42050E-05	AT TIME	650	NSEC
N - 1	IS	5.42050E-05	AT TIME	700	NSEC
N - 1	IS	5.42049E-05	AT TIME	750	NSEC
N - 1	IS	5.42049E-05	AT TIME	800	NSEC
N - 1	IS	5.42049E-05	AT TIME	850	NSEC
N - 1	IS	5.42049E-05	AT TIME	900	NSEC
N - 1	IS	5.42049E-05	AT TIME	950	NSEC
N - 1	IS	5.42049E-05	AT TIME	1000	NSEC
N - 1	IS	5.42049E-05	AT TIME	1050	NSEC
N - 1	IS	5.42049E-05	AT TIME	1100	NSEC
N - 1	IS	5.42049E-05	AT TIME	1150	NSEC
N - 1	IS	5.42049E-05	AT TIME	1200	NSEC
N - 1	IS	5.42049E-05	AT TIME	1250	NSEC
N - 1	IS	5.42049E-05	AT TIME	1300	NSEC
N - 1	IS	5.42049E-05	AT TIME	1350	NSEC
N - 1	IS	5.42049E-05	AT TIME	1400	NSEC
N - 1	IS	5.42049E-05	AT TIME	1450	NSEC
N - 1	IS	5.42049E-05	AT TIME	1500	NSEC
N - 1	IS	5.42049E-05	AT TIME	1550	NSEC
N - 1	IS	5.42049E-05	AT TIME	1600	NSEC
N - 1	IS	5.42049E-05	AT TIME	1650	NSEC
N - 1	IS	5.42049E-05	AT TIME	1700	NSEC
N - 1	IS	5.42049E-05	AT TIME	1750	NSEC
N - 1	IS	5.42049E-05	AT TIME	1800	NSEC
N - 1	IS	5.42049E-05	AT TIME	1850	NSEC
N - 1	IS	5.42048E-05	AT TIME	1900	NSEC
N - 1	IS	5.42048E-05	AT TIME	1950	NSEC
N - 1	IS	5.42048E-05	AT TIME	2000	NSEC

TABLE XI. Output of the HP9830 for n-1 at High Power.

HIGH POWER 11A/CM²

N - 1	IS	5.42153E-05	AT TIME	0	NSEC
N - 1	IS	5.42123E-05	AT TIME	50	NSEC
N - 1	IS	5.42091E-05	AT TIME	100	NSEC
N - 1	IS	5.42071E-05	AT TIME	150	NSEC
N - 1	IS	5.42058E-05	AT TIME	200	NSEC
N - 1	IS	5.42051E-05	AT TIME	250	NSEC
N - 1	IS	5.42046E-05	AT TIME	300	NSEC
N - 1	IS	5.42043E-05	AT TIME	350	NSEC
N - 1	IS	5.42042E-05	AT TIME	400	NSEC
N - 1	IS	5.42041E-05	AT TIME	450	NSEC
N - 1	IS	5.42040E-05	AT TIME	500	NSEC
N - 1	IS	5.42040E-05	AT TIME	550	NSEC
N - 1	IS	5.42039E-05	AT TIME	600	NSEC
N - 1	IS	5.42039E-05	AT TIME	650	NSEC
N - 1	IS	5.42039E-05	AT TIME	700	NSEC
N - 1	IS	5.42039E-05	AT TIME	750	NSEC
N - 1	IS	5.42039E-05	AT TIME	800	NSEC
N - 1	IS	5.42039E-05	AT TIME	850	NSEC
N - 1	IS	5.42039E-05	AT TIME	900	NSEC
N - 1	IS	5.42039E-05	AT TIME	950	NSEC
N - 1	IS	5.42039E-05	AT TIME	1000	NSEC
N - 1	IS	5.42039E-05	AT TIME	1050	NSEC
N - 1	IS	5.42039E-05	AT TIME	1100	NSEC
N - 1	IS	5.42039E-05	AT TIME	1150	NSEC
N - 1	IS	5.42039E-05	AT TIME	1200	NSEC
N - 1	IS	5.42039E-05	AT TIME	1250	NSEC
N - 1	IS	5.42039E-05	AT TIME	1300	NSEC
N - 1	IS	5.42039E-05	AT TIME	1350	NSEC
N - 1	IS	5.42039E-05	AT TIME	1400	NSEC
N - 1	IS	5.42038E-05	AT TIME	1450	NSEC
N - 1	IS	5.42038E-05	AT TIME	1500	NSEC
N - 1	IS	5.42038E-05	AT TIME	1550	NSEC
N - 1	IS	5.42038E-05	AT TIME	1600	NSEC
N - 1	IS	5.42038E-05	AT TIME	1650	NSEC
N - 1	IS	5.42038E-05	AT TIME	1700	NSEC
N - 1	IS	5.42038E-05	AT TIME	1750	NSEC
N - 1	IS	5.42038E-05	AT TIME	1800	NSEC
N - 1	IS	5.42038E-05	AT TIME	1850	NSEC
N - 1	IS	5.42037E-05	AT TIME	1900	NSEC
N - 1	IS	5.42037E-05	AT TIME	1950	NSEC
N - 1	IS	5.42037E-05	AT TIME	2000	NSEC

VII. CALCULATION OF PHASE SHIFT

Beam quality as previously mentioned depends on favorable illumination of the exit aperture; favorable illumination implies near constant phase. Therefore, calculation of the phase shift is important. To calculate the phase shift consider a laser cavity of length L as shown in Figure 10.

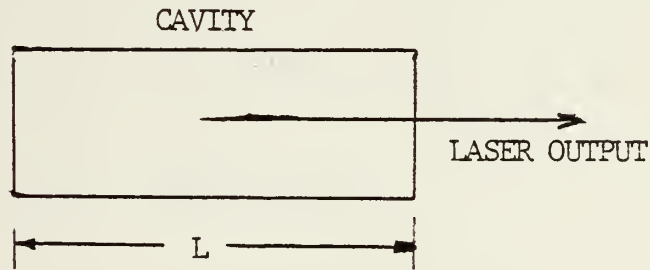


Figure 10. Geometry of Cavity

Other symbols essential for the calculation are

- | | |
|------------------------|--------------------------------|
| N - number of waves | λ - wavelength |
| 1 - denotes low power | n - index of refraction |
| 2 - denotes high power | ν - frequency of the laser |

The number of waves in length L is given by

$$N_i = L/\lambda_i \quad (59)$$

In equation (59) $i = 1, 2$. Wavelength is related to index of refraction by

$$\lambda_i = v_i / \nu = \frac{c}{n_i \nu} \quad (60)$$

Consider two regions in the cavity which are pumped at different power inputs. The difference in the number of waves in the two regions is

$$N_2 - N_1 = L \left(\frac{1}{\lambda_2} - \frac{1}{\lambda_1} \right) \quad (61)$$

Substituting equation (60) into equation (61) yields

$$N_2 - N_1 = L \left(\frac{n_2 \nu}{c} - \frac{n_1 \nu}{c} \right) = \frac{L \nu}{c} (n_2 - n_1) \quad (62)$$

Multiplying the right hand side of equation (62) above and below by n_1 produces

$$N_2 - N_1 = \frac{L \nu n_1}{c} \left(\frac{n_2 - n_1}{n_1} \right) \quad (63)$$

Multiplying equation (63) by $1/L$ and substituting equation (60) yields

$$\frac{N_2 - N_1}{L} = \frac{1}{\lambda_1} \left(\frac{n_2 - n_1}{n_1} \right) \quad (64)$$

The term on the left hand side is the phase shift per unit length of cavity. The phase shift at 1000 nanoseconds for a nonresonance wavelength is now calculated.

$$\lambda = 353 \text{ nm} = 353.0 \text{E-}7 \text{ cm (Figure 8)}$$

From Tables X and XI the values of n are

$$n_2 = 1 + 5.42039\text{E-}05$$

$$n_1 = 1 + 5.42049\text{E-}05$$

Substituting into equation (64)

$$\frac{N_2 - N_1}{L} = \frac{1}{353.0\text{E-}7} \left(\frac{1.0000542039 - 1.0000542049}{1.0000542049} \right) = -2.8327\text{E-}5 \text{ cm}^{-1}$$

The phase shift at 1000 nanoseconds for resonance is calculated below.

$$\lambda = 351.6\text{E-}7$$

The values of n are

$$n_2 = 1 + (-3.71283\text{E-}06)$$

$$n_1 = 1 + (1.6602\text{E-}06)$$

Substituting into equation (64)

$$\frac{N_2 - N_1}{L} = \frac{1}{351.6\text{E-}7} \left(\frac{.999996287170 - 1.000005602}{1.000005602} \right) = -8.959\text{E-}3 \text{ cm}^{-1}$$

The Strehl ratio, which is discussed by Born and Wolfe [21], provides a criterion for beam quality in terms of phase distortion. The ratio is

$$I = I_0 \exp [-(2\pi\delta/\lambda)^2] \quad (65)$$

where I is beam intensity in the far field due to a phase distortion of δ/λ . Based on equation (65), the criterion of

$$\delta/\lambda \leq 0.1 \quad (66)$$

is frequently invoked for satisfactory beam quality. Comparing equations (65) and (61) one notes that

$$N_2 - N_1 = \delta/\lambda \quad (67)$$

The maximum length of the laser cavity, L , for good beam quality is

$$L = \frac{\delta/\lambda}{\left\{ \frac{N_2 - N_1}{L} \right\}} = \frac{(N_2 - N_1)}{\left(\frac{N_2 - N_1}{L} \right)} \quad (68)$$

Substitution of numerical values yields the following results:

- maximum L for a laser operating at a nonresonant wavelength is 35 meters.
- maximum L for a laser operating at a resonant wavelength is 0.1116 meters.

For a nonresonant laser wavelength, a laser cavity with length, L , less than 35 meters will have δ/λ less than 0.1. However, if the laser wavelength is in resonance with neon, a length of laser cavity of only 0.1116 meters will cause $\delta/\lambda = 0.1$. Recall the power into the laser cavity was varied by 10 percent.

VIII. RESULTS

For a power variation of 10 percent the phase shift at nonresonance is small ($N_2 - N_1 = -0.0028$ for a 100 cm cavity) and is dominated by the neon ground state whose population is approximately one million times larger than the other species. However, in the resonance case, if the assumed values of R^* are correct, the index of refraction can be greatly magnified, resulting in a phase shift of $-8.959\text{E-}3 \text{ cm}^{-1}$ as compared to $-2.8327\text{E-}5 \text{ cm}^{-1}$ for nonresonance.

It should be noted that the populations of the neon excited states were calculated using an arbitrary choice to determine the rate constants. However, the population of Ne is approximately six orders of magnitude larger than the neon excited states and thus dominates. As long as the laser is operated away from the $3s \rightarrow 4p$ resonant wavelengths, the phase shift will be negligibly small resulting in satisfactory beam quality.

APPENDIX A

KINETIC REACTIONS AND RATE CONSTANTS FOR XeF SIMULATION

< 1>	(RX47)	NE	EBEM	---->	NF+	F-	EBEM	4.20CF-18	EBEM LP98
< 2>	(NE10)	NE	EBEM	---->	NF*1	EBEM	EBEM	9.25CF-19	EBEM
< 3>	(NE20)	NE	EBEM	---->	NF*2	EBEM	EBEM	2.75CF-19	EBEM
< 4>	(FD05)	F2	F-	---->	F-	F	F	5.00CF-09	ATCH PC38
< 5>	(FD32)	NF3	F-	---->	F-	NF2	NF2	5.00CF-09	ATCH PC38
< 6>	(FD45)	NF2	F-	---->	F-	NF	NF	1.00CF-09	ATCH CAC6
< 7>	(FD46)	NF	F-	---->	F-	N	N	1.00CF-09	ATCH CAC8
< 8>	(FD16)	F*	F-	---->	F	F-	F-	5.00CF-09	SLPR TF28
< 9>	(FD10)	NE*1	F-	---->	NE	F-	F-	1.60CF-10	SLPR
< 10>	(NE20)	NE*2	F-	---->	NE	F-	F-	4.00CF-11	SLPR
< 11>	(XE12)	XE*	F-	---->	XE	F-	F-	2.00CF-09	SLPR
< 12>	(NE11)	NE2+	F-	---->	NE*1	NE	NE	3.15CF-08	
< 13>	(NE21)	NE2+	F-	---->	NE*2	NE	NE	3.50CF-09	
< 14>	(NE11)	NE3+	F-	---->	NF*1	NE	NE	2.65CF-08	RCMP
< 15>	(NE21)	NE3+	F-	---->	NF*2	NE	NE	1.50CF-09	RCMP
< 16>	(XE41)	XE2+	F-	---->	XE*	XE	XE	3.00CF-07	RCMP SR27
< 17>	(XE39)	XE2+	F-	---->	XE*	XE	XE	3.00CF-07	RCMP GA35
< 18>	(RX20)	NE*2+	F-	---->	XE*	NE	NE	6.00CF-08	RCMP GA97
< 19>	(RX11)	NE*1+	F-	---->	NF*1	XE	XE	3.60CF-08	RCMP
< 20>	(RX21)	XE*F+	F-	---->	NF*2	XE	XE	2.40CF-08	RCMP
< 21>	(FE11)	FE*1	NE	---->	FE2*	NE	NE	4.00CF-34	
< 22>	(FE21)	NE*2	NE	---->	NF2*	NE	NE	1.00CF-34	
< 23>	(NE22)	NE*+		---->	NE	NE	NE	1.00CF 0? L	5B95
< 24>	(NE26)	NE+	NE	---->	NE2+	NE	NE	4.60CF-32	CCC3
< 25>	(NE34)	NE2+	NE	---->	NE3+	NE	NE	4.60CF-32	3C91

< 26> (AL35)	NE	NE	NE	NE	NE	2.00CF-12	GUES
< 27> (AL19)	NE	NE	NE	NE	NE	1.60CF-32	SP58
< 28> (AL21)	NE	NE	NE	NE	NE	5.00CF-32	CU97
< 29> (AL28)	NE	NE	NE	NE	NE	3.33CF 01 L	SP53
< 30> (AL33)	NE	NE	NE	NE	NE	1.00CF-31	AP67
< 31> (AL34)	NE	NE	NE	NE	NE	2.00CF-31	AP67
< 32> (AL38)	NE	NE	NE	NE	NE	6.00CF-32	CU97
< 33> (AL40)	NE	NE	NE	NE	NE	1.70CF-13	AP77
< 34> (AL12)	NE	NE	NE	NE	NE	4.44CF-11	PENG
< 35> (AL22)	NE	NE	NE	NE	NE	2.56CF-11	PENG
< 36> (AL12)	NE	NE	NE	NE	NE	1.32CF-11	PENG
< 37> (AL22)	NE	NE	NE	NE	NE	8.80CF-12	PENG
< 38> (AL12)	NE	NE	NE	NE	NE	7.50CF-11	SP58
< 39> (AL13)	NE	NE	NE	NE	NE	2.30CF-11	GA28
< 40> (AL34)	NE	NE	NE	NE	NE	1.00CF-14 U	JM38
< 41> (AL17)	NE	NE	NE	NE	NE	1.00CF-32	AP77
< 42> (AL16)	NE	NE	NE	NE	NE	5.00CF-14 U	JM38
< 43> (AL19)	NE	NE	NE	NE	NE	5.00CF-14 U	JM38
< 44> (AL21)	NE	NE	NE	NE	NE	3.00CF-12	CU97
< 45> (AL30)	NE	NE	NE	NE	NE	2.00CF-10	AP77
< 46> (AL37)	NE	NE	NE	NE	NE	2.00CF-11	TFAB
< 47> (AL23)	NE	NE	NE	NE	NE	5.00CF-14	CU97
< 48> (AL26)	NE	NE	NE	NE	NE	1.00CF-31	AP67
< 49> (AL29)	NE	NE	NE	NE	NE	1.00CF 01 L	CU97
< 50> (AL31)	NE	NE	NE	NE	NE	5.00CF-14	CU97

< 51> (LX52)	XLN5+	X5		X52+	NF	5.00CF-14	GU97
< 52> (RX33)	XL	H405+		X5+	E-	1.00CF-19 Q	CAC7
< 53> (FL14)	F	F	NF	F2	NF	1.00CF-34	LT78
< 54> (FD19)	F*	F2		F2+	F	3.50CF-10	AV28
< 55> (FD21)	F*	NF3		F*	NF2	2.50CF-10	HFC8
< 56> (FL03)	F*	NF2		F2*	NF	2.50CF-10	CAC8
< 57> (FD04)	F*	NF		F2*	I	2.50CF-10	CAC8
< 58> (FD25)	F2*	F2		F2	F	3.50CF-10	HFC8
< 59> (FD27)	F2*	NF3		F2	NF2	4.10CF-10	HFC8
< 60> (FD47)	F2*	NF2		F3	NF	4.10CF-10	GA25
< 61> (FD66)	F2*	NF		F2	N	4.10CF-10	GA25
< 62> (FD31)	NF2	F	NL	NF3	NF	1.00CF-32	TFC8
< 63> (FD43)	NF	NF	NL	N2F2	NF	1.00CF-32	TFC8
< 64> (FD49)	NF	F	NF	NF2	NF	1.00CF-32	TFC8
< 65> (FD50)	N	F	NL	NF	NF	1.00CF-32	TFC8
< 66> (FD55)	N	N	NF	N2	NF	1.00CF-32	TFC8
< 67> (FD53)	N2	F2	NL	N2F2	NF	1.00CF-42	CUC8
< 68> (FL54)	NF3+	E-		NF2	F	5.00CF-08	RCMT GU97
< 69> (FL36)	F23+	F-		F2	F	1.00CF-06	CAC7
< 70> (FD56)	NF2+	F-		NF2	F	1.00CF-06	CAC8
< 71> (FD57)	NF+	F-		NF	F	1.00CF-06	CAC8
< 72> (FD53)	NF2+	F-		NF	F	5.00CF-03	CAC8
< 73> (FD54)	NF+	E-		N	F	5.00CF-03	CAC8
< 74> (FD51)	F*			F	HNU3	1.00CF 05 L	PC26
< 75> (FD52)	F2*			F	F	4.10CF 01 L	HFC8

HNL53F

< 76>	(HR07)	F2*	NE	NE	NE	NE	1.000CF-23	U	FFCB
< 77>	(HR16)	F*	NE	NE	NE	NE	3.100CF-10	PFAC	SR58
< 78>	(H113)	F2*	NE	NE	NE	NE	1.000CF-10		SR58
< 79>	(H117)	NE*	NE	NE	NE	NE	1.000CF-10		SR58
< 80>	(H118)	NE*	NE	NE	NE	NE	1.000CF-10		GACB
< 81>	(H119)	NE*	NE	NE	NE	NE	1.000CF-10		GACB
< 82>	(H120)	NE*	NE	NE	NE	NE	1.000CF-10		GACB
< 83>	(H121)	NE*	NE	NE	NE	NE	1.000CF-10		GACB
< 84>	(H17)	NE*	F2	NE	NE	NE	1.000CF-10		GACB
< 85>	(H27)	NE*	F2	NE	NE	NE	1.280CF-10		
< 86>	(H17)	NE*	NE	NE	NE	NE	8.200CF-11		
< 87>	(H27)	NE*	NE	NE	NE	NE	8.400CF-11		
< 88>	(H07)	NE*	F2	NE	NE	NE	2.100CF-11		
< 89>	(H10)	NE*	NE	NE	NE	NE	4.100CF-10		GAL5
< 90>	(H10)	NE*	NE	NE	NE	NE	2.500CF-11		SR58
< 91>	(H12)	NE*	NE	NE	NE	NE	3.030CF-06		F3RA
< 92>	(H15)	NE*	NE	NE	NE	NE	3.250CF-06		F3RA
< 93>	(H13)	NE*	NE	NE	NE	NE	3.000CF-06		GACB
< 94>	(H19)	NE*	NE	NE	NE	NE	3.000CF-06		GACB
< 95>	(H18)	NE*	NE	NE	NE	NE	1.000CF-35	U	FFCB
< 96>	(H20)	NE*	NE	NE	NE	NE	8.000CF-11		
< 97>	(H13)	NE*	NE	NE	NE	NE	2.000CF-11		
< 98>	(H23)	NE*	NE	NE	NE	NE	8.000CF-11		
< 99>	(H25)	NE*	NE	NE	NE	NE	2.000CF-11		
< 100>	(H24)	NE*	NE	NE	NE	NE	2.500CF-11		GACB
							2.500CF-11		GACB

<101> (NL03)	NEF*				F	HN107F	2.38CF-00 L	SP58
<102> (NL01)	NEF*				NE		2.50CF-01 L	GUC8
<103> (NL02)	NEF*	F2			F	F2	5.00CF-10	CL97
<104> (NL03)	NEF*	NF3			F	NF3	1.00CF-10	SK58
<105> (NL06)	NEF*	XF			F-	NE	1.00CF-10	PENG SP58
<106> (NL12)	NEF*	NF2			F	NF2	1.00CF-10	GAC8
<107> (NL13)	NEF*	NF			F	NF	1.00CF-10	GAC8
<108> (NL01)	NEF*				F	HN460F	9.20CF-01 L	W58
<109> (XL02)	NEF*	NE			F	NF	1.31CF-15	CS78
<110> (XL03)	NEF*	XE			F	XF	1.24CF-11	CS78
<111> (XL04)	NEF*	NF3			F	NF3	4.04CF-12	CS78
<112> (XL06)	NEF*	NE			F	NF	1.00CF-36	ACNF
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<114> (XL08)	NEF*	NF			F	NF	4.00CF-12	CLC8
<115> (XL11)	NEF*	F-					6.00CF-07	CLC8
<116> (XL12)	NEF*	F-			XE		6.00CF-07	CLC8
<117> (XL13)	NEF*	F-			NE		6.00CF-07	GUC8
<118> (XL14)	NEF*	F-			XE	XF	6.00CF-07	CLC8
<119> (XL21)	NEF*	F-			NE	FORMI	1.50CF-06	GAC8
<120> (XL23)	NEF*	F-			FORMI		1.50CF-06	GAC8
<121> (XL29)	NEF*	NE			CL	CLFAC	1.70CF-14	GAC8
<122> (XL26)	NEF*	F-			XF	FORMI	1.50CF-06	GAC8
<123> (XL13)	NEF*	F2			F	FORMI	3.75CF-10	GAC8
<124> (XL11)	NEF*	XF			F	FORMI	6.50CF-11	GAC8
<125> (XL14)	NEF*	NF2			NE	FORMI	9.00CF-11	GAC8

<126>	(AV35)	AEFAC	AE	AEAV	VF	NF	FORMC	3.03CF-35	GAC8
<127>	(AV31)	AEFAV	AE	AEAC	VE	QUFN		7.40CF-13	GAC8
<128>	(AV39)	AEFAV	AE	AE	F	NE	NE	1.34CF-33	GAC8
<129>	(AV40)	AEFAV	AE	AEAC	VE	NE	QUFN	1.34CF-33	GAC8
<130>	(AV17)	AEFAV	F2	AE	F	F2	QUFN	3.80CF-10	GAC8
<131>	(AV35)	AEFAV	AE	AE	F	XF	QUFN	6.00CF-11	GAC8
<132>	(AV32)	AEFAV	AF	AEAC	XE	QUFN		4.70CF-11	GAC8
<133>	(AV34)	AEFAV	NE	AE	F	NE	QUFN	7.70CF-13	GAC8
<134>	(AV04)	AEFAV		AE	F	PN340F	QUFN	1.42CF-01 L	GAC8
<135>	(AV02)	AEFAV	AE	AEFA	NE			1.00CF-11	GAC8
<136>	(AVJ3)	AEFAV	NE	AEFAV	NE			1.00CF-11	GAC8
<137>	(AF11)	F2*	XE	AEFA	F	FORMI		6.50CF-11	CHG*
<138>	(AF13)	AE*	F2	AEFA	F	FORMN		3.75CF-10	CHG*
<139>	(AF14)	AE*	NE2	AEFA	NE	FORMN		5.00CF-11	CHG*
<140>	(AF15)	AE*	NE3	AEFA	NE2	FORMN		9.00CF-11	VPH6
<141>	(AF25)	AE*	NE	AEFA	N	FORMN		1.00CF-10	GAC8
<142>	(AF21)	AE2*	F2	AEFA	XF	F	FORMN	7.50CF-10	CAA7
<143>	(AF22)	AE2*	NE3	AEFA	XF	NE2	FORMN	2.50CF-11	SR58
<144>	(AF23)	AE*	F-	AEFA	FORMI			1.50CF-06	CHG*
<145>	(AF26)	AE2*	F-	AEFA	AE	FORMI		1.50CF-06	CHG*
<146>	(AF27)	NEAE*	F-	AEFA	NE	FORMI		1.50CF-06	CHG*
<147>	(AF28)	AE3*	F-	AEFA	XF	AE	FORMI	3.00CF-06	GAC8
<148>	(AF29)	AEFAC	NE	AEFA	VE	FORMC		1.70CF-14	CHG*
<149>	(AF30)	AEFAV	AE	AEFA	XF	FORMC		2.12CF-12	ES78
<150>	(AF31)	AEFAV	NE3	AEFA	VF3	FORMC		2.44CF-12	ES78

<151>	(XF33)	XFFAC	NE	NE	----	XFF*	RE	RL	EQPVC	3.00CF-15	CHG*
<152>	(XF37)	AE2*	NF2		----	XFF*	XE	NF	EQPVC	3.00CF-11	CACB
<153>	(XF38)	AE2*	NF		----	XFF*	XE	RI	EQPVC	3.00CF-11	CACB
<154>	(XF34)	XFFAC	F2		----	XFF*	F2	EQPVC		2.00CF-12	CACB
<155>	(XF35)	XFFAC	NF2		----	XFF*	NF2	EQPVC		2.00CF-12	CACB
<156>	(XF36)	XFFAC	NF		----	XFF*	NF	EQPVC		2.00CF-12	CACB
<157>	(XQ02)	XFF*	F-		----	XFF*	F-	EQPVC		2.00CF-08	5R05
<158>	(XQ07)	XFF*	F2		----	XFF*	F2	EQPVC		3.80CF-10	FA3R
<159>	(XQ08)	XFF*	NF2		----	XFF*	F2	EQPVC		1.00CF-10	CACB
<160>	(XQ09)	XFF*	NF		----	XFF*	F2	EQPVC		1.00CF-10	CACB
<161>	(XQ17)	XFF*	XE	XE	----	XFF*	F2	EQPVC	QUEN	2.20CF-29	FA3R
<162>	(XQ21)	XFF*	NF		----	XFF*	RE	QUEN		7.40CF-13	FS7B
<163>	(XQ22)	XFF*	XE		----	XFFAC	XE	QUEN		4.70CF-11	FS7B
<164>	(XQ23)	XFF*	NF3		----	XFFAC	NF3	QUEN		5.40CF-11	FS7B
<165>	(XQ24)	XFF*	NF		----	XFF*	F2	EQPVC		7.40CF-14	U
<166>	(XQ25)	XFF*	XE		----	XFF*	F2	EQPVC		6.00CF-11	FS7B
<167>	(XQ26)	XFF*	NF3		----	XFF*	F2	EQPVC		3.00CF-11	FS7B
<168>	(XQ27)	XFF*	XE	F2	----	XFF*	F2	EQPVC	QUEN	4.17CF-31	MR??
<169>	(XQ28)	XFF*	XE	F2	----	XFFAC	XE	EQPVC		4.17CF-31	MR??
<170>	(XQ29)	XFF*	NF		----	XFF*	F2	EQPVC		1.34CF-33	ECEN
<171>	(XQ30)	XFF*	NF	NL	----	XFFAC	NF	EQPVC		1.34CF-33	ECEN
<172>	(XQ33)	XFF*			----	XFF*	HN352F			1.42CF-01	CE57
<173>	(XQ36)	XFF*			----	XFF*	HN352L			1.42CF-01	CE57
<174>	(XQ37)	XFF*	HN352L		----	XFF*	HN352L			1.41CF-15	P 1ASF 1P97
<175>	(XQ38)	XFF*	HN352L		----	XFF*	HN352L			1.41CF-15	P 7P16

APPENDIX B

CALCULATION OF RATE CONSTANT k_5

Consider a thin layer of active optical medium, with gain α , cm^{-1} , in the laser cavity of length ℓ , cm. The change in intensity I , watts/cm^2 , within the thin layer is

$$\Delta I = I_{\text{out}} - I_{\text{in}} = \alpha I \ell \quad (69)$$

The number of photons per unit time entering the layer of active optical medium is

$$\dot{N}_{\text{in}} = \frac{I_{\text{in}} A}{h\nu} \quad (70)$$

A corresponding term for the number of photons leaving per unit time is

$$\dot{N}_{\text{out}} = \frac{I_{\text{out}} A}{h\nu} \quad (71)$$

The rate of production of photons within the thin layer is the difference between \dot{N}_{out} and \dot{N}_{in} which is

$$\left\{ \begin{array}{l} \text{rate of pro-} \\ \text{duction} \\ \text{of photons} \end{array} \right\} = \dot{N}_{\text{out}} - \dot{N}_{\text{in}} = \frac{A}{h\nu} (I_{\text{out}} - I_{\text{in}}) \quad (72)$$

Equation (72) neglects spontaneous emission. Combining equations (69) and (72) yields

$$\text{production rate} = \frac{\alpha A \ell I}{h\nu} \quad (73)$$

From equation (19) the rate of production of photons by stimulated emission is

$$\text{production rate} = k_5 [h\nu] [\text{KrF}^*] A \ell \quad (74)$$

where the symbol $[h\nu]$ means number of photons per unit volume.

The gain coefficient also is equal to

$$\alpha = \sigma [\text{KrF}^*] \quad (75)$$

where σ is the optical cross section for stimulated emission at the frequency ν . The number density of photons $[h\nu]$ is related to intensity by

$$[h\nu] = \frac{I}{ch\nu} \quad (76)$$

where c is the velocity of the photons; c , obviously, is the speed of an electromagnetic wave.

Combining equations (73) to (76) gives

$$k_5 = c\sigma \quad (77)$$

The dimensions of k_5 are cm^3/sec ; the dimension of σ is cm , and c is cm^2/sec . From reference [2] the value of σ is $5.0\text{E}-16 \text{ cm}^2$, and c is $3.0\text{E}10 \text{ cm/sec}$. Substituting these values into equation (77) yields

$$k_5 = 1.5\text{E-}05 \text{ cm}^3/\text{sec}$$

This is the value for k_5 used in the computer program.

APPENDIX C
CALCULATION OF PHOTON CONCENTRATION

The concentration of photons is given by equation (76)
as

$$[h\nu] = I/ch\nu$$

Assuming,

$$I = 10 \text{ kW/cm}^2 \text{ (saturation value)}$$

$$c = 3.0\text{E}10 \text{ cm/sec}$$

$$h = 6.6256\text{E}-34 \text{ J-sec}$$

$$\lambda_o = 248.0\text{E}-9 \text{ m}$$

the concentration of photons can be calculated.

$$[h\nu] = \frac{10.0\text{E}3}{(3.0\text{E}10)(6.6256\text{E}-34) \left(\frac{3.0\text{E}8}{248.0\text{E}9} \right)}$$

$$[h\nu] = 4.159\text{E}11/\text{cm}^3 .$$

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